

## Operational Amplifiers

# Input/Output Full Swing High Voltage Operation CMOS Operational Amplifiers

**BD7561G BD7561SG BD7562xxx BD7562Sxxx**

### General Descriptions

The BD7561G / BD7562xxx are input-output full swing high voltage operable CMOS operational amplifiers.

The BD7561SG / BD7562Sxxx have an extended operating temperature range.

They have wide operating voltage range of +5V to +14.5V (single power supply), high slew rate and low input bias current.

### Features

- Wide Operating Supply Voltage
- Input and Output Full Swing
- Low Supply Current
- High Large Signal Voltage Gain
- Wide Temperature Range

### Applications

- Sensor Amplifier
- Industrial Equipment
- Consumer Equipment

### Key Specifications

- Operating Supply Voltage Range:
  - Single supply +5V to +14.5V
  - Split supply  $\pm 2.5V$  to  $\pm 7.25V$
- Operating Temperature Range:
  - BD7561G/ BD7562xxx -40°C to +85°C
  - BD7561SG/ BD7562Sxxx -40°C to +105°C
- Slew Rate: 0.9V/ $\mu$ s(Typ)
- Input Offset Current: 1pA (Typ)
- Input Bias Current: 1pA (Typ)

### Package

	W(Typ) x D(Typ) x H(Max)
SSOP5	2.90mm x 2.80mm x 1.15mm
SOP8	5.00mm x 6.20mm x 1.61mm
MSOP8	2.90mm x 4.00mm x 0.83mm

### Simplified Schematic

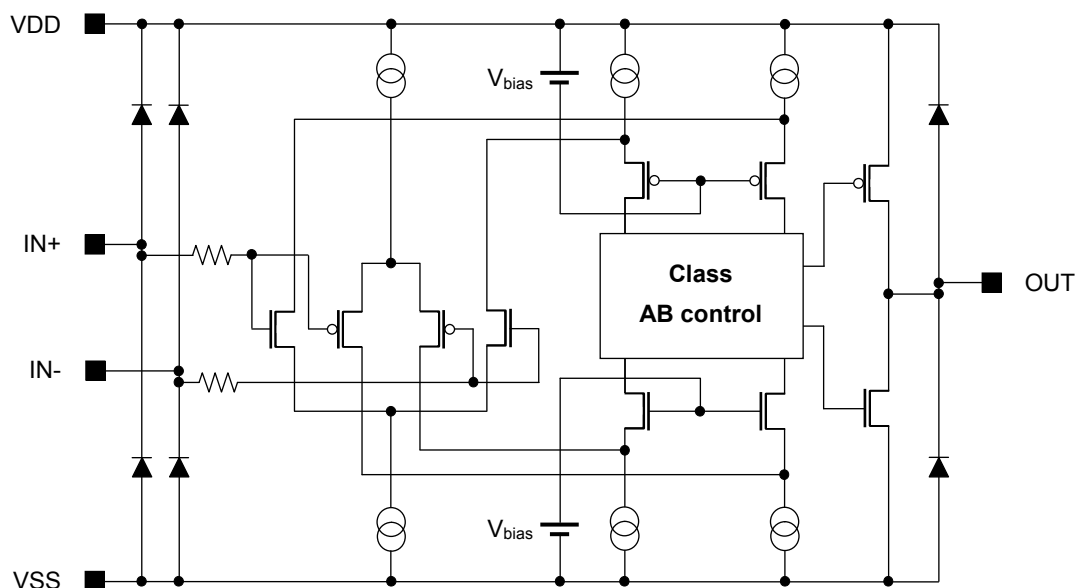
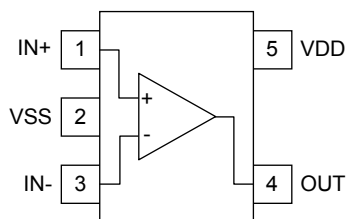


Figure 1. Simplified Schematic

○Product structure : Silicon monolithic integrated circuit ○This product has no designed protection against radioactive rays.

## Pin Configuration

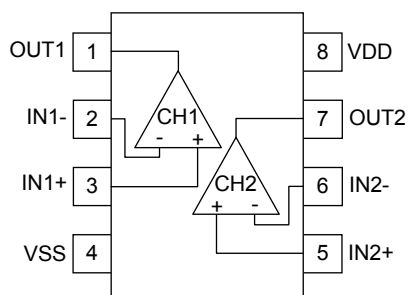
BD7561G, BD7561SG: SSOP5



Pin No.	Pin Name
1	IN+
2	VSS
3	IN-
4	OUT
5	VDD

BD7562F, BD7562SF: SOP8

BD7562FVM, BD7562SFVM: MSOP8



Pin No.	Pin Name
1	OUT1
2	IN1-
3	IN1+
4	VSS
5	IN2+
6	IN2-
7	OUT2
8	VDD

Package		
SSOP5	SOP8	MSOP8
BD7561G BD7561SG	BD7562F BD7562SF	BD7562FVM BD7562SFVM

## Ordering Information

B	D	7	5	6	x	x	x	x	x
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-	x	x
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Part Number

BD7561G  
BD7561SG  
BD7562xxx  
BD7562Sxxx

Package

G : SSOP5  
F : SOP8  
FVM : MSOP8

Packaging and forming specification

E2: Embossed tape and reel  
(SOP8)  
TR: Embossed tape and reel  
(SSOP5/MSOP8)

## Line-up

Temp	Channels	Supply Current	Package		Orderable Part Number
-40°C to +85°C	1ch	370μA	SSOP5	Reel of 3000	BD7561G-TR
	2ch	750μA	SOP8	Reel of 2500	BD7562F-E2
			MSOP8	Reel of 3000	BD7562FVM-TR
-40°C to +105°C	1ch	370μA	SSOP5	Reel of 3000	BD7561SG-TR
	2ch	750μA	SOP8	Reel of 2500	BD7562SF-E2
			MSOP8	Reel of 3000	BD7562SFVM-TR

**Absolute Maximum Ratings** ( $T_A=25^{\circ}\text{C}$ )

Parameter	Symbol		Rating				Unit
			BD7561G	BD7562xxx	BD7561SG	BD7562Sxxx	
Supply Voltage	VDD-VSS		+15.5				V
Power Dissipation	P <sub>D</sub>	SSOP5	0.54 <sup>(Note 1,4)</sup>	-	0.54 <sup>(Note 1,4)</sup>	-	W
		SOP8	-	0.55 <sup>(Note 2,4)</sup>	-	0.55 <sup>(Note 2,4)</sup>	
		MSOP8	-	0.47 <sup>(Note 3,4)</sup>	-	0.47 <sup>(Note 3,4)</sup>	
Differential Input Voltage <sup>(Note 5)</sup>	V <sub>ID</sub>		VDD - VSS				V
Input Common-mode Voltage Range	V <sub>ICM</sub>		(VSS - 0.3) to (VDD + 0.3)				V
Input Current <sup>(Note 6)</sup>	I <sub>I</sub>		±10				mA
Operating Supply Voltage	V <sub>opr</sub>	Single	+5 to +14.5				V
		Split	±2.5 to ±7.25				
Operating Temperature	T <sub>opr</sub>		-40 to +85		-40 to +105		°C
Storage Temperature	T <sub>stg</sub>		-55 to +125				°C
Maximum Junction Temperature	T <sub>Jmax</sub>		+125				°C

(Note 1) To use at temperature above  $T_A=25^{\circ}\text{C}$  reduce 5.4mW/ $^{\circ}\text{C}$ .(Note 2) To use at temperature above  $T_A=25^{\circ}\text{C}$  reduce 5.5mW/ $^{\circ}\text{C}$ .(Note 3) To use at temperature above  $T_A=25^{\circ}\text{C}$  reduce 4.7mW/ $^{\circ}\text{C}$ .

(Note 4) Mounted on a FR4 glass epoxy PCB 70mm×70mm×1.6mm (copper foil area less than 3%).

(Note 5) The voltage difference between inverting input and non-inverting input is the differential input voltage.  
Then input pin voltage is set to more than VSS.(Note 6) An excessive input current will flow when input voltages of more than VDD+0.6V or less than VSS-0.6V are applied.  
The input current can be set to less than the rated current by adding a limiting resistor.

Caution: Operating the IC over the absolute maximum ratings may damage the IC. The damage can either be a short circuit between pins or an open circuit between pins and the internal circuitry. Therefore, it is important to consider circuit protection measures, such as adding a fuse, in case the IC is operated over the absolute maximum ratings.

## Electrical Characteristics

OBD7561G, BD7561SG (Unless otherwise specified VDD=+12V, VSS=0V, T<sub>A</sub>=25°C)

Parameter	Symbol	Temperature Range	Limit			Unit	Conditions
			Min	Typ	Max		
Input Offset Voltage <sup>(Note 7,8)</sup>	V <sub>IO</sub>	25°C	-	1	9	mV	VDD=5 to 14.5V
		Full range	-	-	10		
Input Offset Current <sup>(Note 7)</sup>	I <sub>IO</sub>	25°C	-	1	-	pA	-
Input Bias Current <sup>(Note 7)</sup>	I <sub>B</sub>	25°C	-	1	-	pA	-
Supply Current <sup>(Note 8)</sup>	I <sub>DD</sub>	25°C	-	370	550	μA	R <sub>L</sub> =∞, A <sub>V</sub> =0dB, VDD=5V, IN+=2.5V
		Full range	-	-	600		
		25°C	-	440	650		R <sub>L</sub> =∞, A <sub>V</sub> =0dB, VDD=12V, IN+=6.0V
		Full range	-	-	700		
Maximum Output Voltage (High)	V <sub>OH</sub>	25°C	VDD-0.1	-	-	V	R <sub>L</sub> =10kΩ
Maximum Output Voltage (Low)	V <sub>OL</sub>	25°C	-	-	VSS+0.1	V	R <sub>L</sub> =10kΩ
Large Single Voltage Gain	A <sub>V</sub>	25°C	70	95	-	dB	R <sub>L</sub> =10kΩ
Input Common-mode Voltage Range	V <sub>ICM</sub>	25°C	0	-	12	V	VSS to VDD
Common-mode Rejection Ratio	CMRR	25°C	45	60	-	dB	-
Power Supply Rejection Ratio	PSRR	25°C	60	80	-	dB	-
Output Source Current <sup>(Note 9)</sup>	I <sub>SOURCE</sub>	25°C	3	8	-	mA	OUT=VDD-0.4V
Output Sink Current <sup>(Note 9)</sup>	I <sub>SINK</sub>	25°C	4	14	-	mA	OUT=VSS+0.4V
Slew Rate	SR	25°C	-	0.9	-	V/μs	C <sub>L</sub> =25pF
Gain Bandwidth	GBW	25°C	-	1.0	-	MHz	C <sub>L</sub> =25pF, A <sub>V</sub> =40dB
Phase Margin	θ	25°C	-	50	-	deg	C <sub>L</sub> =25pF, A <sub>V</sub> =40dB
Total Harmonic Distortion + Noise	THD+N	25°C	-	0.05	-	%	OUT=1V <sub>P-P</sub> , f=1kHz

(Note 7) Absolute value.

(Note 8) Full range: BD7561G: T<sub>A</sub>=-40°C to +85°C BD7561S: T<sub>A</sub>=-40°C to +105°C.

(Note 9) Under the high temperature environment, consider the power dissipation of IC when selecting the output current.

When the terminal short circuits are continuously output, the output current is reduced to climb to the temperature inside IC.

**Electrical Characteristics – continued**OBD7562xxx, BD7562Sxxx (Unless otherwise specified VDD=+12V, VSS=0V, T<sub>A</sub>=25°C)

Parameter	Symbol	Temperature Range	Limit			Unit	Conditions
			Min	Typ	Max		
Input Offset Voltage <sup>(Note 10,11)</sup>	V <sub>IO</sub>	25°C	-	1	9	mV	VDD=5 to 14.5V
		Full range	-	-	10		
Input Offset Current <sup>(Note 10)</sup>	I <sub>IO</sub>	25°C	-	1	-	pA	-
Input Bias Current <sup>(Note 10)</sup>	I <sub>B</sub>	25°C	-	1	-	pA	-
Supply Current <sup>(Note 11)</sup>	I <sub>DD</sub>	25°C	-	750	1300	μA	R <sub>L</sub> =∞, All Op-Amps A <sub>V</sub> =0dB, VDD=5V, I <sub>N</sub> =±2.5V
		Full range	-	-	1500		
		25°C	-	900	1400		R <sub>L</sub> =∞, All Op-Amps A <sub>V</sub> =0dB, VDD=12V, I <sub>N</sub> =±6.0V
		Full range	-	-	1600		
Maximum Output Voltage (High)	V <sub>OH</sub>	25°C	VDD-0.1	-	-	V	R <sub>L</sub> =10kΩ
Maximum Output Voltage (Low)	V <sub>OL</sub>	25°C	-	-	VSS+0.1	V	R <sub>L</sub> =10kΩ
Large Signal Voltage Gain	A <sub>V</sub>	25°C	70	95	-	dB	R <sub>L</sub> =10kΩ
Input Common-mode Voltage Range	V <sub>ICM</sub>	25°C	0	-	12	V	VSS to VDD
Common-mode Rejection Ratio	CMRR	25°C	45	60	-	dB	-
Power Supply Rejection Ratio	PSRR	25°C	60	80	-	dB	-
Output Source Current <sup>(Note 12)</sup>	I <sub>SOURCE</sub>	25°C	3	8	-	mA	OUT=VDD-0.4V
Output Sink Current <sup>(Note 12)</sup>	I <sub>SINK</sub>	25°C	4	14	-	mA	OUT=VSS+0.4V
Slew Rate	SR	25°C	-	0.9	-	V/μs	C <sub>L</sub> =25pF
Gain Bandwidth	GBW	25°C	-	1.0	-	MHz	C <sub>L</sub> =25pF, A <sub>V</sub> =40dB
Phase Margin	θ	25°C	-	50	-	deg	C <sub>L</sub> =25pF, A <sub>V</sub> =40dB
Total Harmonic Distortion + Noise	THD+N	25°C	-	0.05	-	%	OUT=1V <sub>P-P</sub> , f=1kHz
Channel Separation	CS	25°C	-	100	-	dB	A <sub>V</sub> =40dB, OUT=1V <sub>rms</sub>

(Note 10) Absolute value.

(Note 11) Full range : BD7562xxx : T<sub>A</sub>=-40°C to +85°C BD7562Sxxx : T<sub>A</sub>=-40°C to +105°C.

(Note 12) Under the high temperature environment, consider the power dissipation of IC when selecting the output current.

When the terminal short circuits are continuously output, the output current is reduced to climb to the temperature inside IC.

## Description of Electrical Characteristics

Described below are descriptions of the relevant electrical terms used in this datasheet. Items and symbols used are also shown. Note that item name and symbol and their meaning may differ from those on another manufacturer's document or general document.

### 1. Absolute maximum ratings

Absolute maximum rating items indicate the condition which must not be exceeded. Application of voltage in excess of absolute maximum rating or use out of absolute maximum rated temperature environment may cause deterioration of characteristics.

- (1) Supply Voltage (VDD/VSS)  
Indicates the maximum voltage that can be applied between the VDD terminal and VSS terminal without deterioration or destruction of characteristics of internal circuit.
- (2) Differential Input Voltage ( $V_{ID}$ )  
Indicates the maximum voltage that can be applied between non-inverting and inverting terminals without damaging the IC.
- (3) Input Common-mode Voltage Range ( $V_{ICM}$ )  
Indicates the maximum voltage that can be applied to the non-inverting and inverting terminals without deterioration or destruction of electrical characteristics. Input common-mode voltage range of the maximum ratings does not assure normal operation of IC. For normal operation, use the IC within the input common-mode voltage range characteristics.
- (4) Power Dissipation ( $P_D$ )  
Indicates the power that can be consumed by the IC when mounted on a specific board at the ambient temperature 25°C (normal temperature). As for package product,  $P_d$  is determined by the temperature that can be permitted by the IC in the package (maximum junction temperature) and the thermal resistance of the package.

### 2. Electrical characteristics

- (1) Input Offset Voltage ( $V_{IO}$ )  
Indicates the voltage difference between non-inverting terminal and inverting terminals. It can be translated into the input voltage difference required for setting the output voltage at 0 V.
- (2) Input Offset Current ( $I_{IO}$ )  
Indicates the difference of input bias current between the non-inverting and inverting terminals.
- (3) Input Bias Current ( $I_B$ )  
Indicates the current that flows into or out of the input terminal. It is defined by the average of input bias currents at the non-inverting and inverting terminals.
- (4) Supply Current ( $I_{DD}$ )  
Indicates the current that flows within the IC under specified no-load conditions.
- (5) Maximum Output Voltage(High) / Maximum Output Voltage(Low) ( $V_{OH}/V_{OL}$ )  
Indicates the voltage range of the output under specified load condition. It is typically divided into maximum output voltage high and low. Maximum output voltage high indicates the upper limit of output voltage. Maximum output voltage low indicates the lower limit.
- (6) Large Signal Voltage Gain ( $A_V$ )  
Indicates the amplifying rate (gain) of output voltage against the voltage difference between non-inverting terminal and inverting terminal. It is normally the amplifying rate (gain) with reference to DC voltage.  
 $A_V = (\text{Output voltage}) / (\text{Differential Input voltage})$
- (7) Input Common-mode Voltage Range ( $V_{ICM}$ )  
Indicates the input voltage range where IC normally operates.
- (8) Common-mode Rejection Ratio (CMRR)  
Indicates the ratio of fluctuation of input offset voltage when the input common mode voltage is changed. It is normally the fluctuation of DC.  
 $CMRR = (\text{Change of Input common-mode voltage}) / (\text{Input offset fluctuation})$
- (9) Power Supply Rejection Ratio (PSRR)  
Indicates the ratio of fluctuation of input offset voltage when supply voltage is changed.  
It is normally the fluctuation of DC.  
 $PSRR = (\text{Change of power supply voltage}) / (\text{Input offset fluctuation})$
- (10) Output Source Current/ Output Sink Current ( $I_{SOURCE} / I_{SINK}$ )  
The maximum current that can be output from the IC under specific output conditions. The output source current indicates the current flowing out from the IC, and the output sink current indicates the current flowing into the IC.
- (11) Slew Rate (SR)  
Indicates the ratio of the change in output voltage with time when a step input signal is applied.
- (12) Gain Bandwidth (GBW)  
The product of the open-loop voltage gain and the frequency at which the voltage gain decreases 6dB/octave.
- (13) Phase Margin ( $\theta$ )  
Indicates the margin of phase from 180 degree phase lag at unity gain frequency.

## (14) Total Harmonic Distortion + Noise (THD+N)

Indicates the fluctuation of input offset voltage or that of output voltage with reference to the change of output voltage of driven channel.

## (15) Channel Separation (CS)

Indicates the fluctuation in the output voltage of the driven channel with reference to the change of output voltage of the channel which is not driven.

## Typical Performance Curves

OBD7561G, BD7561SG

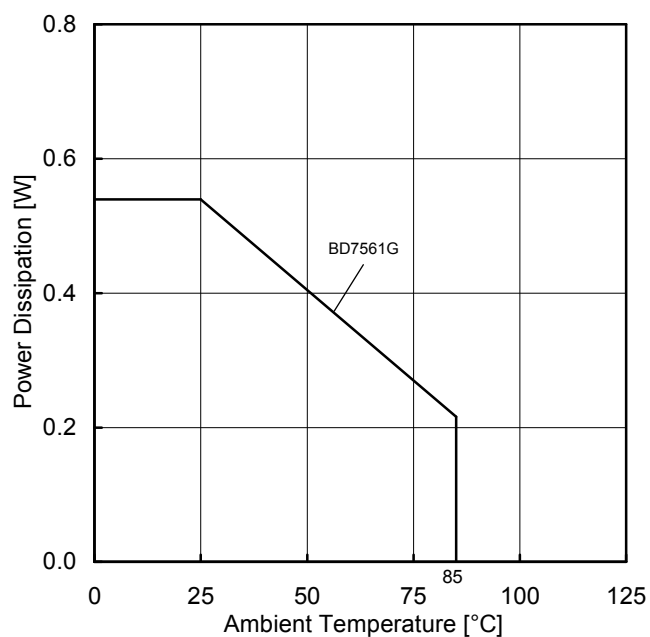


Figure 2.  
Power Dissipation vs Ambient Temperature  
(Derating Curve)

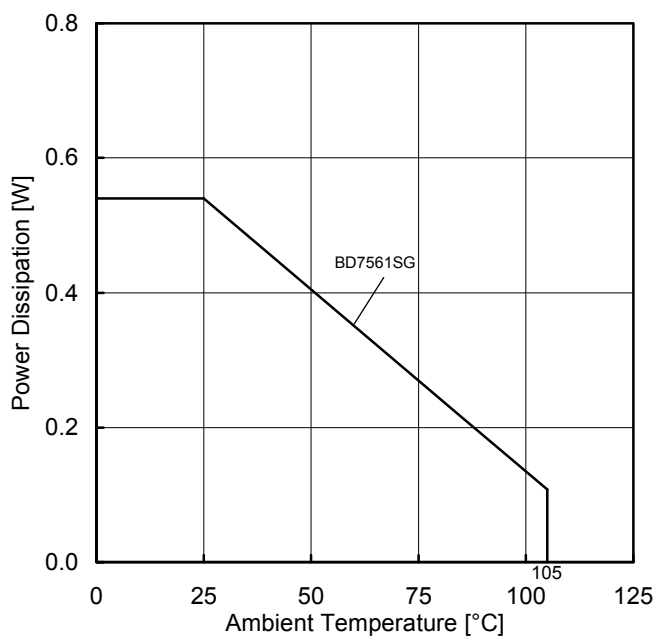


Figure 3.  
Power Dissipation vs Ambient Temperature  
(Derating Curve)

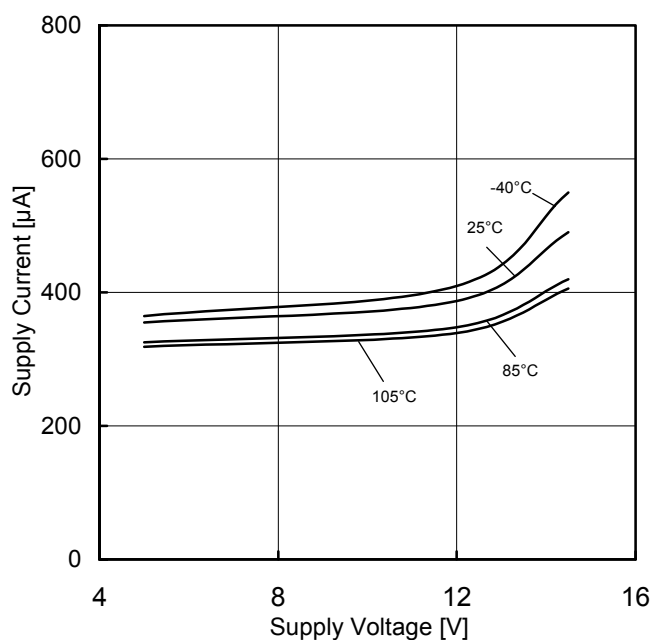


Figure 4.  
Supply Current vs Supply Voltage

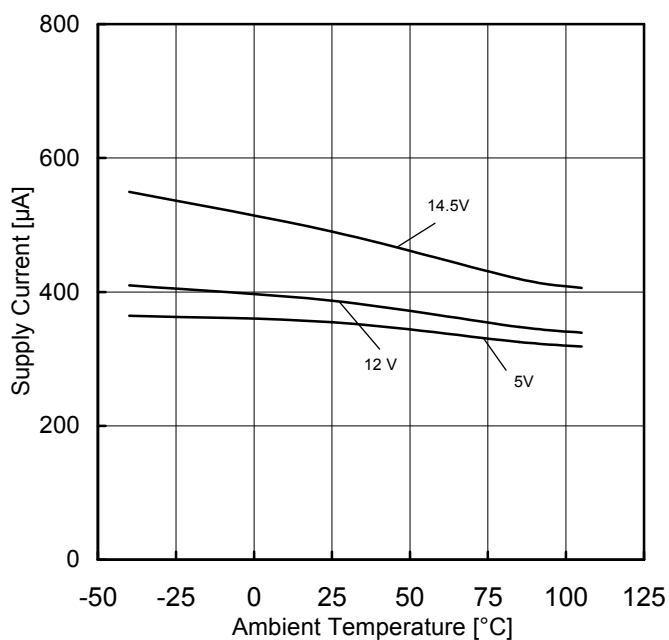


Figure 5.  
Supply Current vs Ambient Temperature

(\*) The above characteristics are measurements of typical sample, they are not guaranteed.  
BD7561G: -40°C to +85°C BD7561SG: -40°C to +105°C



## Typical Performance Curves - continued

OBD7561G, BD7561SG

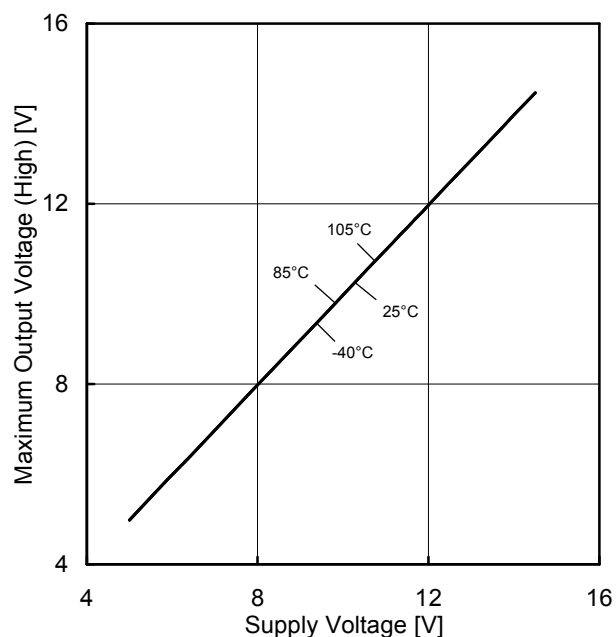


Figure 6.  
Maximum Output Voltage (High) vs Supply Voltage  
( $R_L=10k\Omega$ )

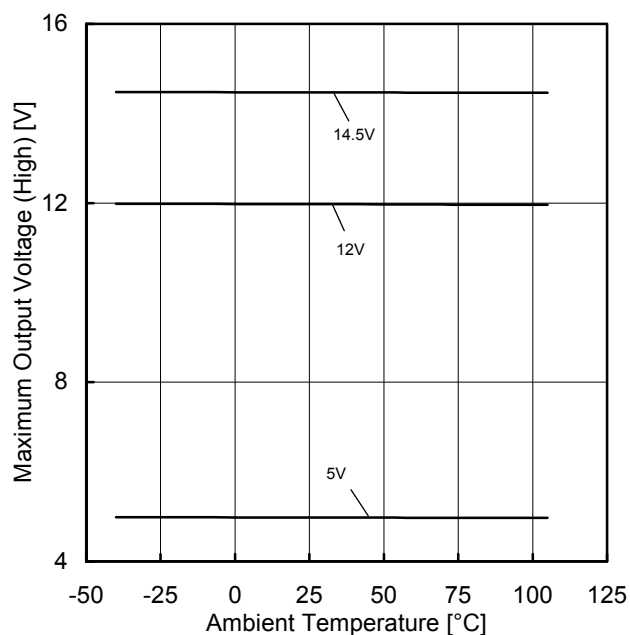


Figure 7.  
Maximum Output Voltage (High) vs Ambient Temperature  
( $R_L=10k\Omega$ )

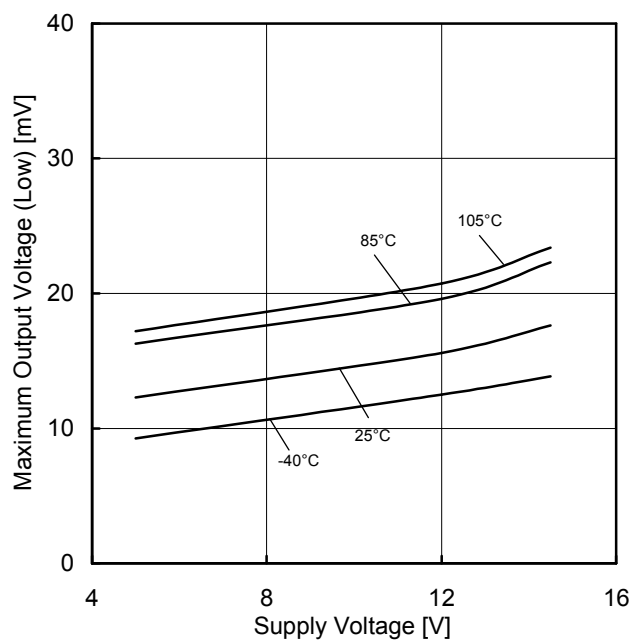


Figure 8.  
Maximum Output Voltage (Low) vs Supply Voltage  
( $R_L=10k\Omega$ )

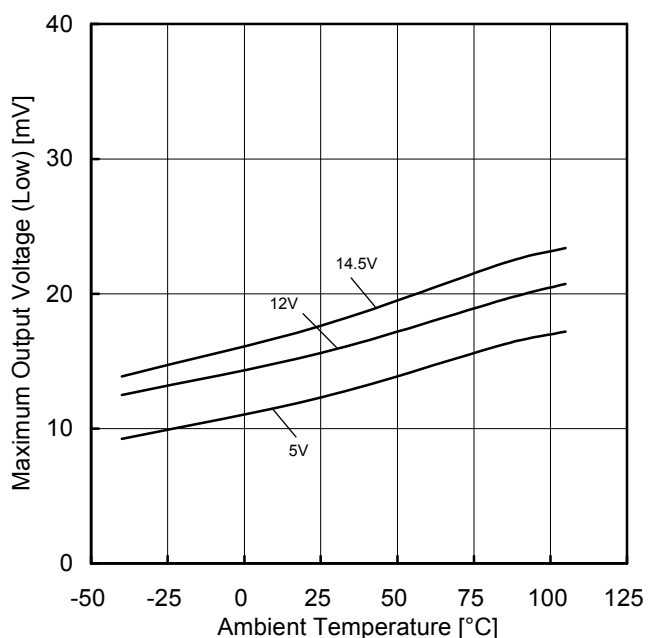


Figure 9.  
Maximum Output Voltage (Low) vs Ambient Temperature  
( $R_L=10k\Omega$ )

(\*) The above characteristics are measurements of typical sample, they are not guaranteed.  
BD7561G: -40°C to +85°C BD7561SG: -40°C to +105°C

## Typical Performance Curves - continued

OBD7561G, BD7561SG

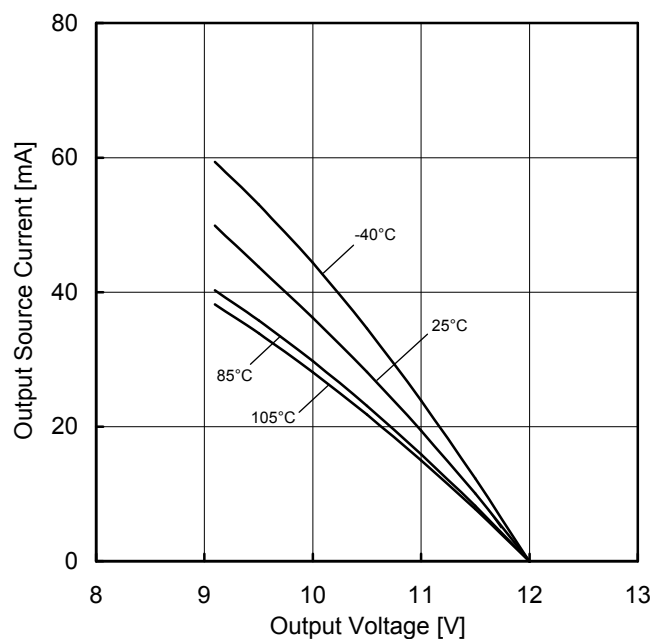


Figure 10.  
Output Source Current vs Output Voltage  
(VDD=12V)

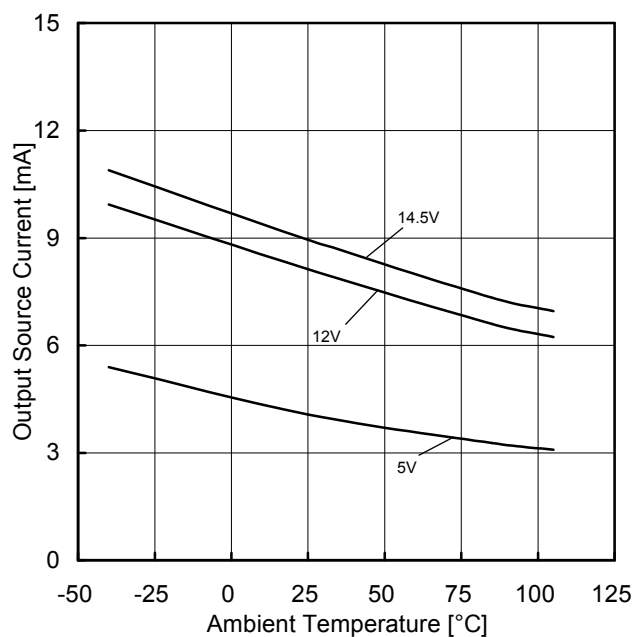


Figure 11.  
Output Source Current vs Ambient Temperature  
(OUT=VDD-0.4V)

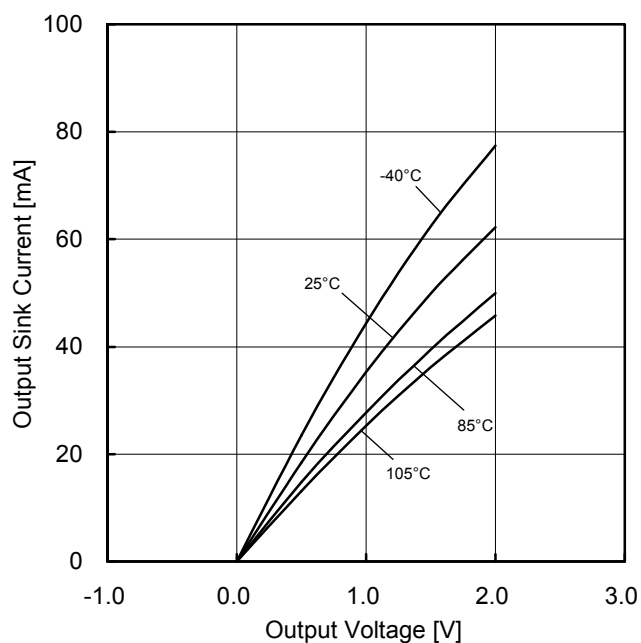


Figure 12.  
Output Sink Current vs Output Voltage  
(VDD=3V)

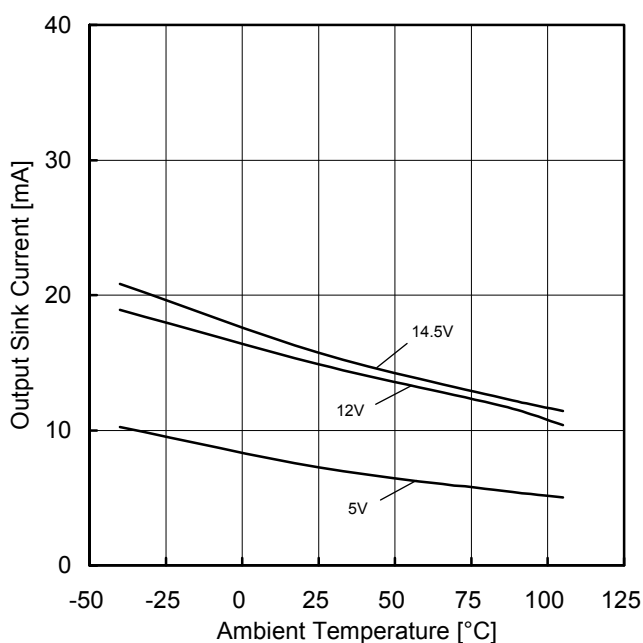


Figure 13.  
Output Sink Current vs Ambient Temperature  
(OUT=VSS+0.4V)

(\*) The above characteristics are measurements of typical sample, they are not guaranteed.  
BD7561G: -40°C to +85°C BD7561SG: -40°C to +105°C

## Typical Performance Curves - continued

OBD7561G, BD7561SG

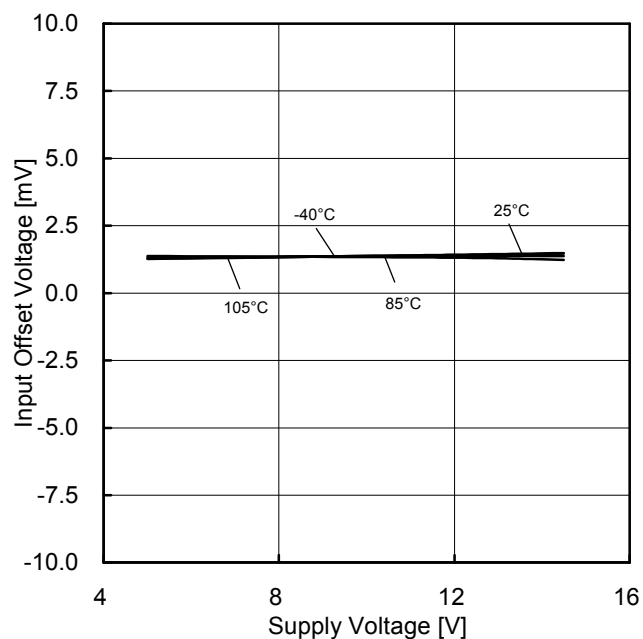


Figure 14.  
Input Offset Voltage vs Supply Voltage  
( $V_{ICM}=V_{DD}/2$ ,  $E_K=-V_{DD}/2$ )

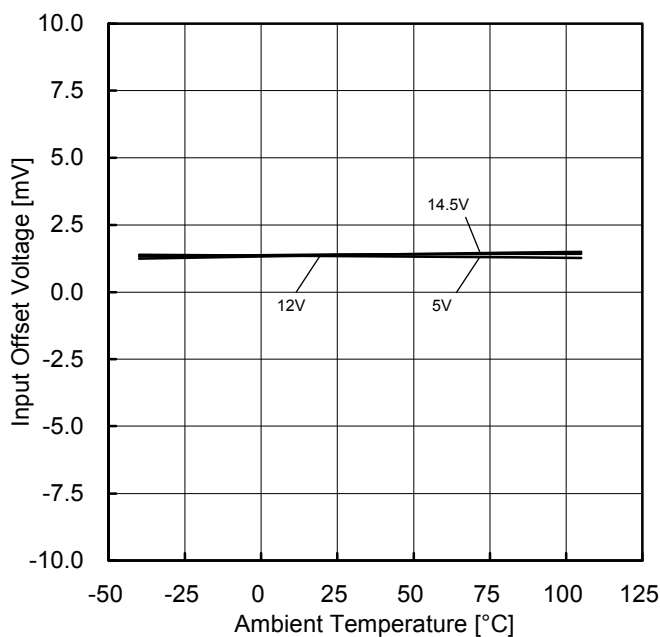


Figure 15.  
Input Offset Voltage vs Ambient Temperature  
( $V_{ICM}=V_{DD}/2$ ,  $E_K=-V_{DD}/2$ )

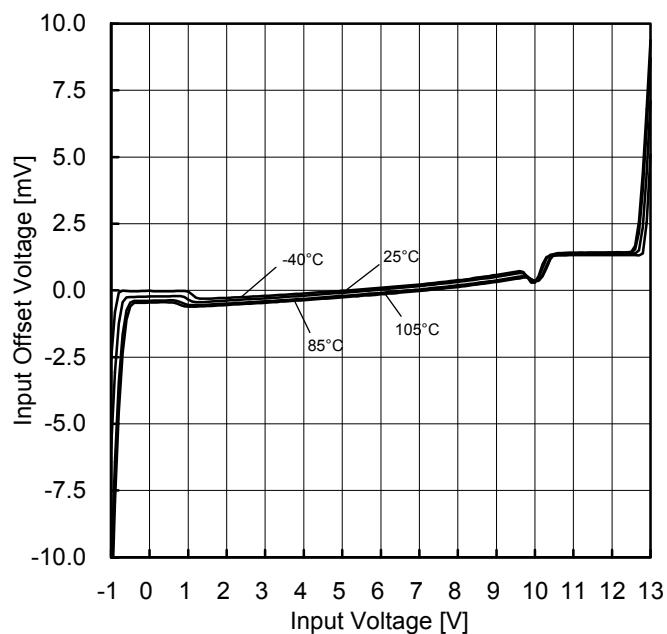


Figure 16.  
Input Offset Voltage vs Input Voltage  
( $V_{DD}=12V$ )

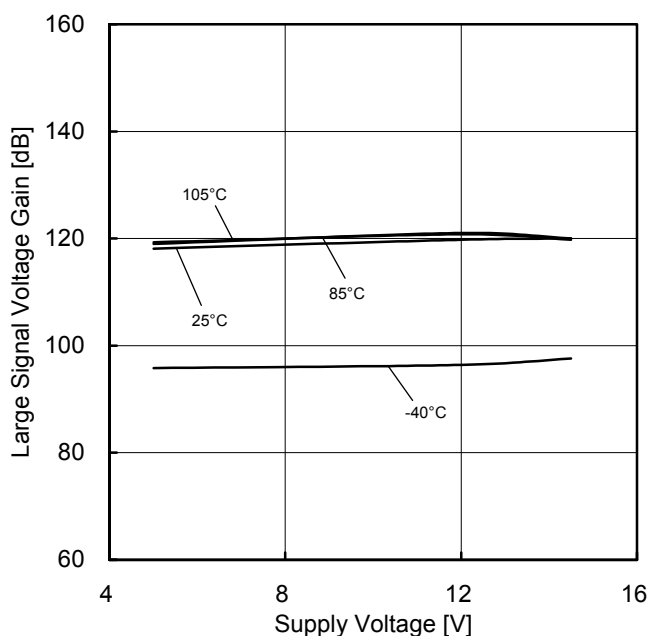


Figure 17.  
Large Signal Voltage Gain vs Supply Voltage

(\*) The above characteristics are measurements of typical sample, they are not guaranteed.  
BD7561G: -40°C to +85°C BD7561SG: -40°C to +105°C

## Typical Performance Curves - continued

OBD7561G, BD7561SG

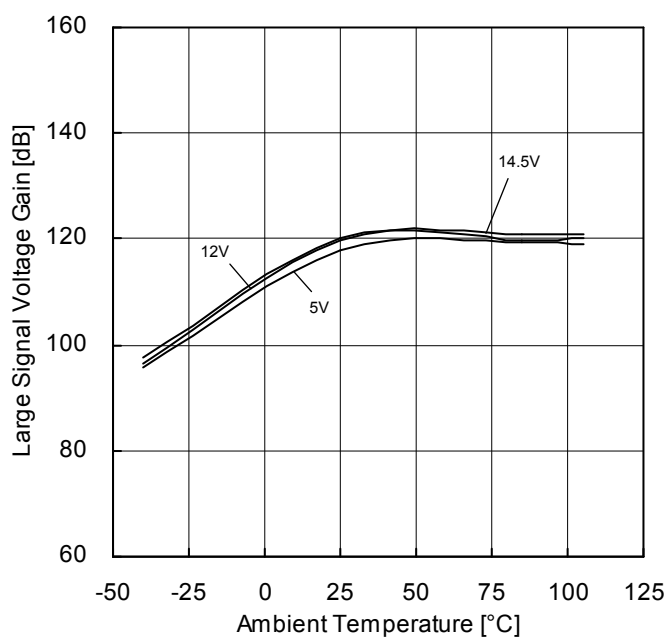


Figure 18.  
Large Signal Voltage Gain vs Ambient Temperature

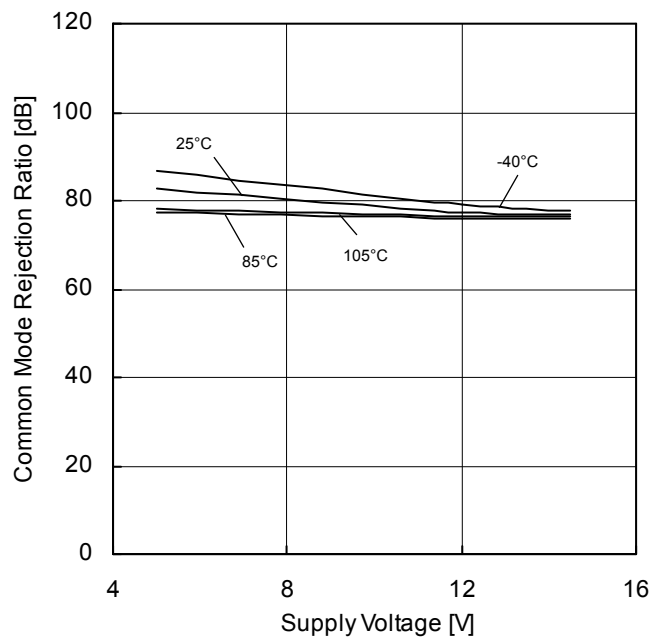


Figure 19.  
Common Mode Rejection Ratio vs Supply Voltage  
(VDD=12V)

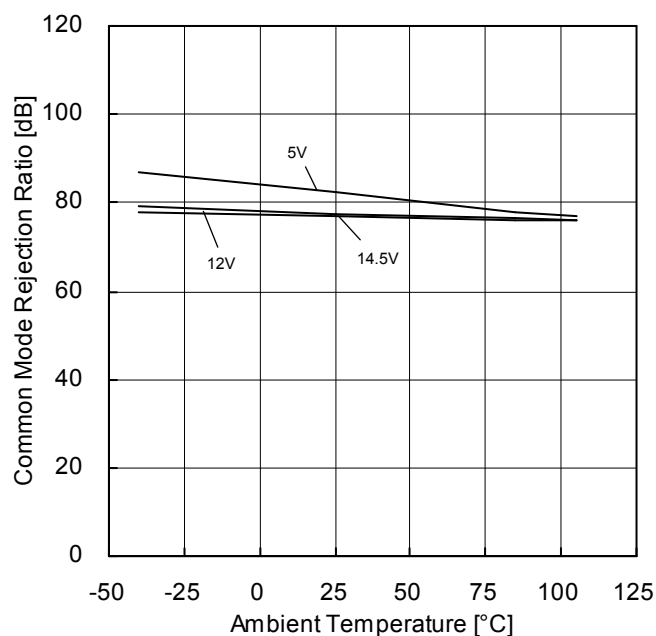


Figure 20.  
Common Mode Rejection Ratio vs Ambient Temperature  
(VDD=12V)

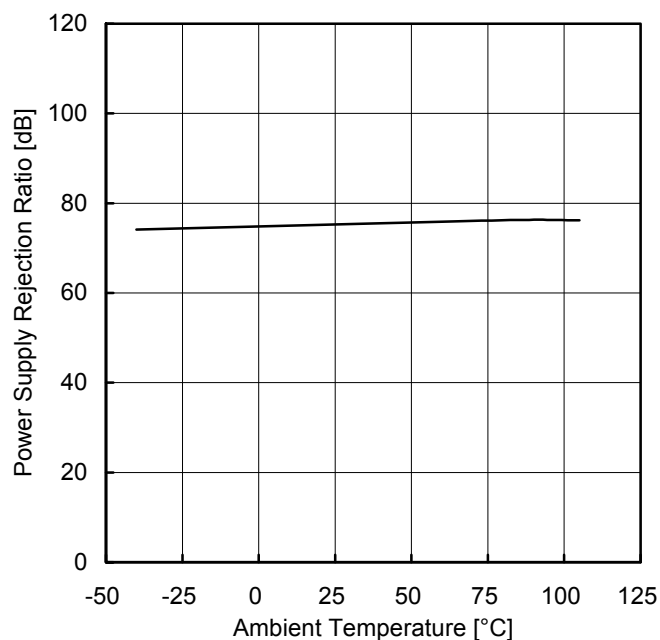


Figure 21.  
Power Supply Rejection Ratio vs Ambient Temperature

(\*) The above characteristics are measurements of typical sample, they are not guaranteed.  
BD7561G: -40°C to +85°C BD7561SG: -40°C to +105°C

## Typical Performance Curves - continued

OBD7561G, BD7561SG

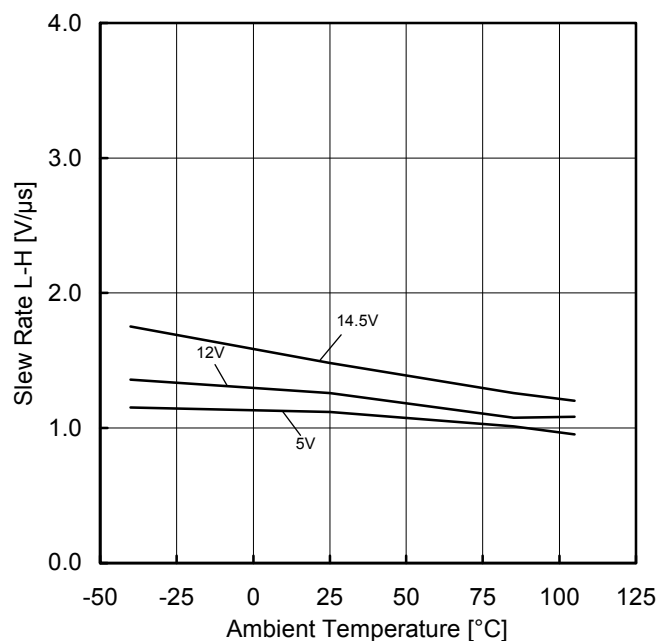


Figure 22.  
Slew Rate L-H vs Ambient Temperature

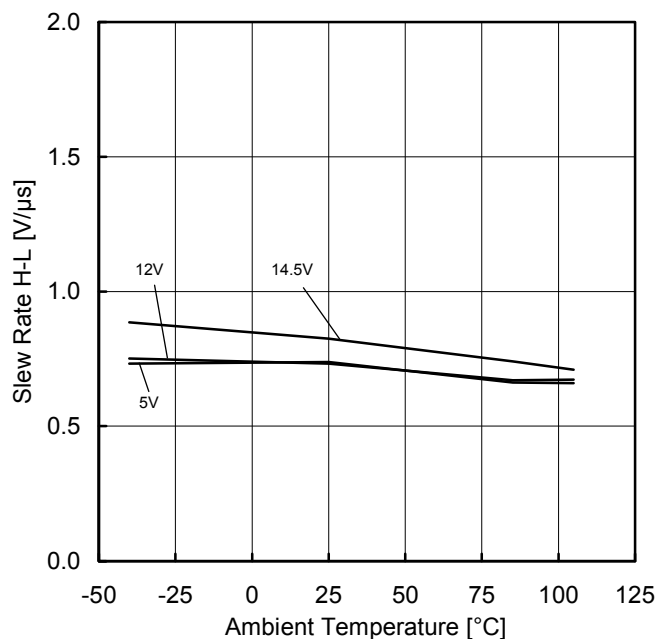


Figure 23.  
Slew Rate H-L vs Ambient Temperature

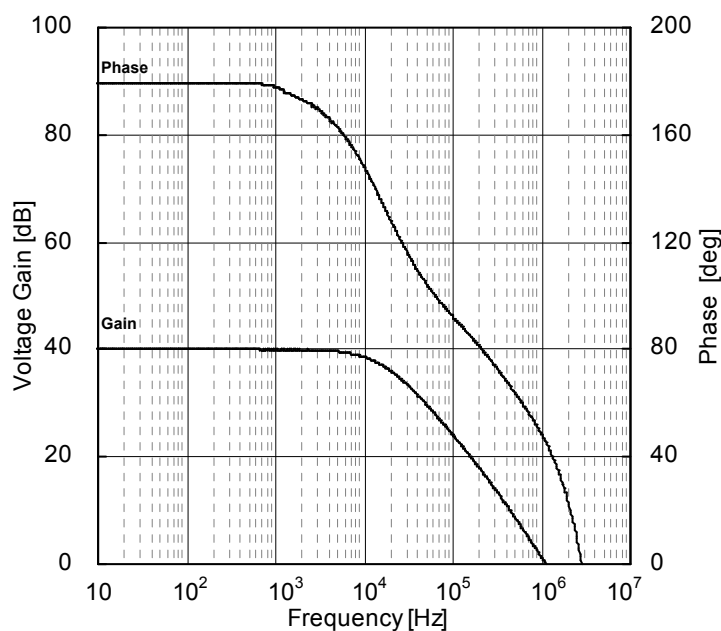


Figure 24.  
Voltage Gain • Phase vs Frequency

(\*) The above characteristics are measurements of typical sample, they are not guaranteed.  
BD7561G: -40°C to +85°C BD7561SG: -40°C to +105°C

## Typical Performance Curves - continued

OBD7562xxx, BD7562Sxxx

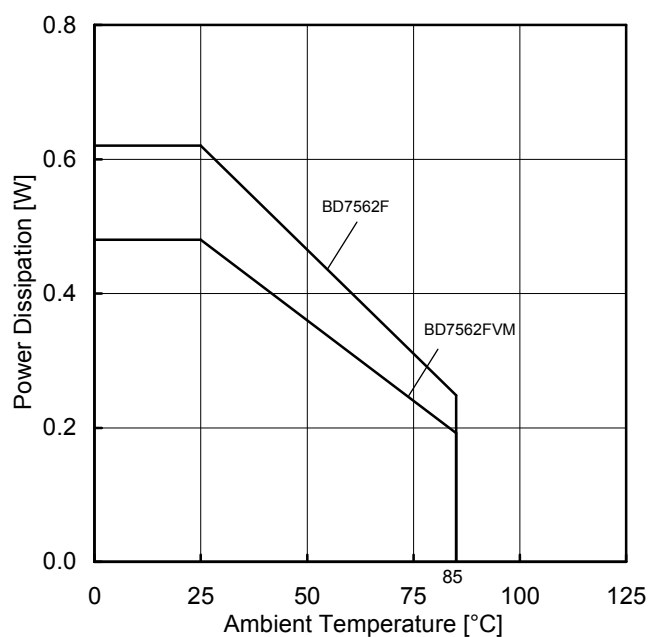


Figure 25.  
Power Dissipation vs Ambient Temperature  
(Derating Curve)

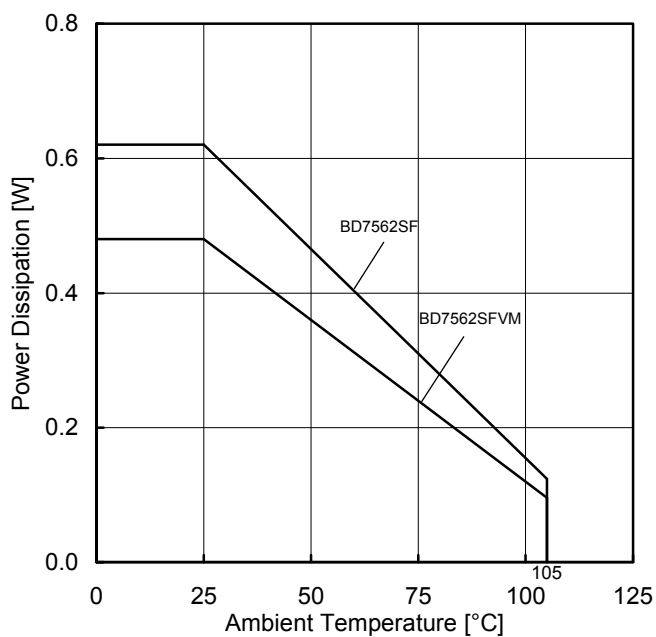


Figure 26.  
Power Dissipation vs Ambient Temperature  
(Derating Curve)

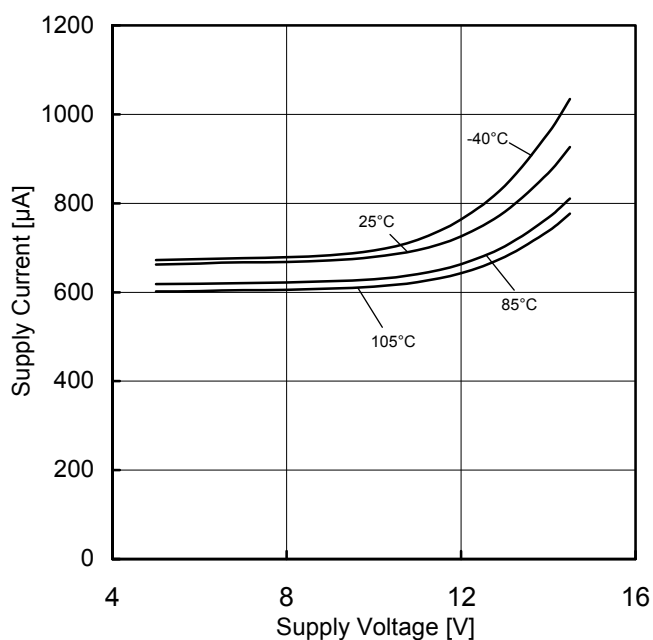


Figure 27.  
Supply Current vs Supply Voltage

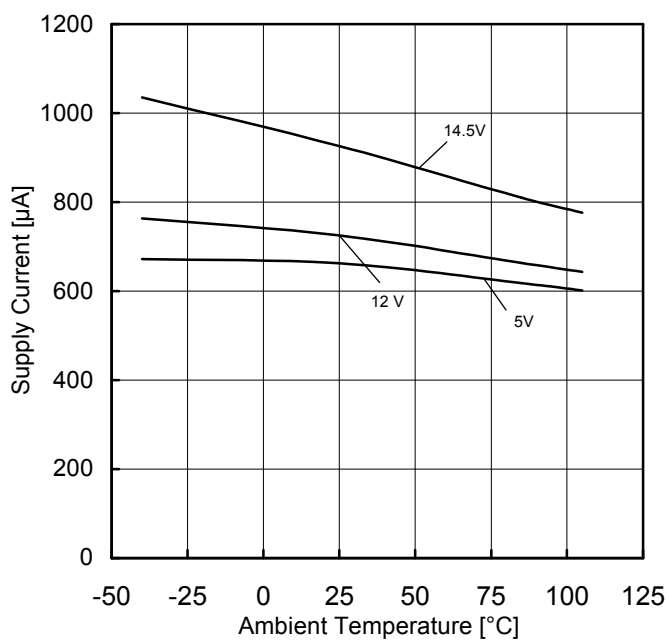


Figure 28.  
Supply Current vs Ambient Temperature

(\*) The above characteristics are measurements of typical sample, they are not guaranteed.  
BD7562xxx: -40°C to +85°C BD7562Sxxx: -40°C to +105°C

## Typical Performance Curves - continued

OBD7562xxx, BD7562Sxxx

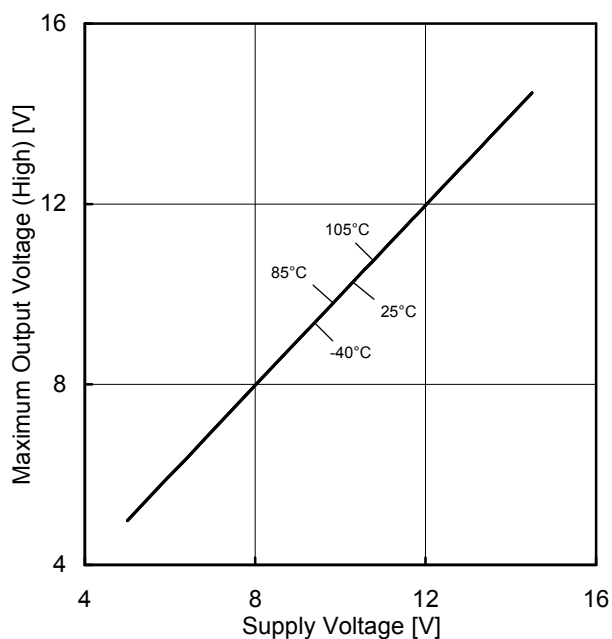


Figure 29.  
Maximum Output Voltage (High) vs Supply Voltage  
( $R_L=10k\Omega$ )

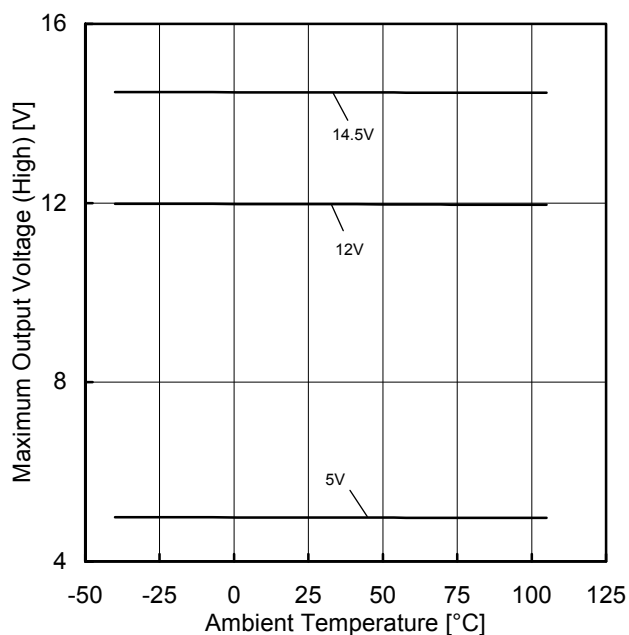


Figure 30.  
Maximum Output Voltage (High) vs Ambient Temperature  
( $R_L=10k\Omega$ )

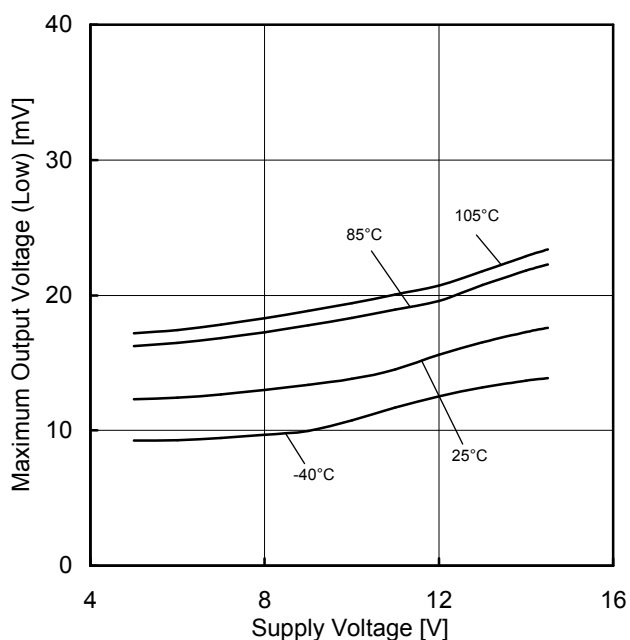


Figure 31.  
Maximum Output Voltage (Low) vs Supply Voltage  
( $R_L=10k\Omega$ )

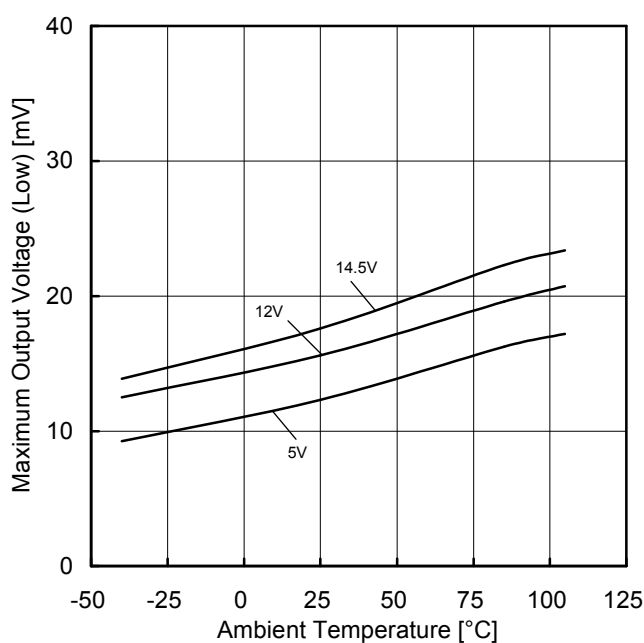


Figure 32.  
Maximum Output Voltage (Low) vs Ambient Temperature  
( $R_L=10k\Omega$ )

(\*) The above characteristics are measurements of typical sample, they are not guaranteed.  
BD7562xxx: -40°C to +85°C BD7562Sxxx: -40°C to +105°C

## Typical Performance Curves - continued

OBD7562xxx, BD7562Sxxx

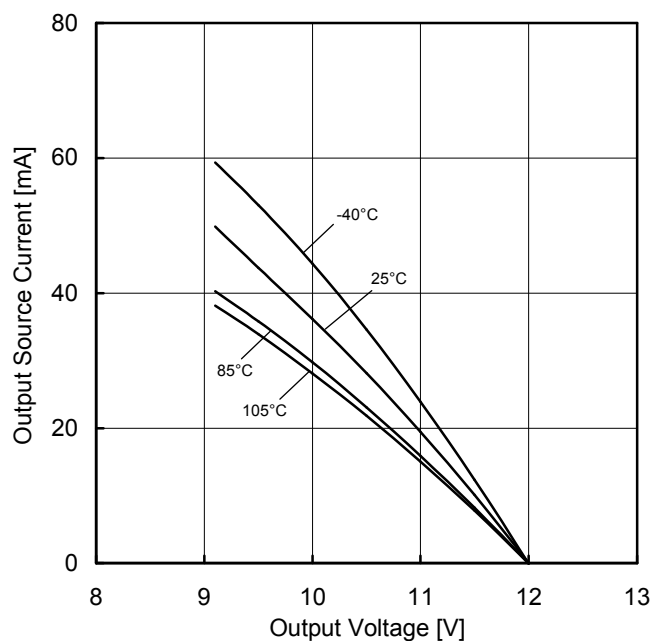


Figure 33.  
Output Source Current vs Output Voltage  
(VDD=12V)

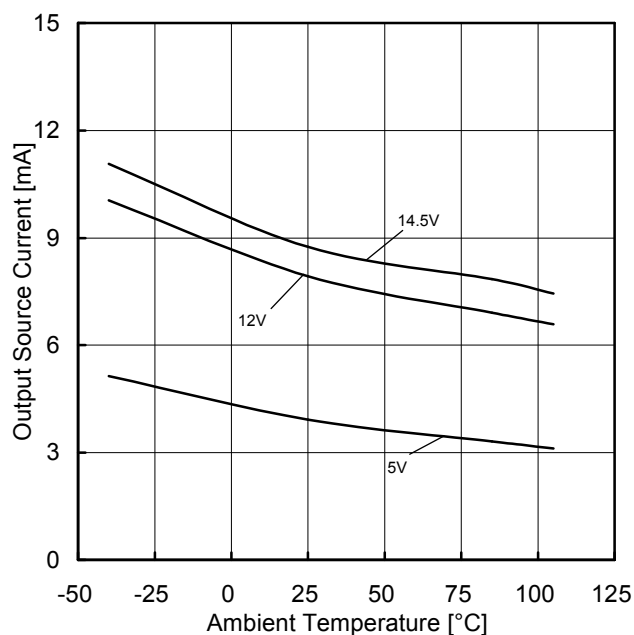


Figure 34.  
Output Source Current vs Ambient Temperature  
(OUT=VDD-0.4V)

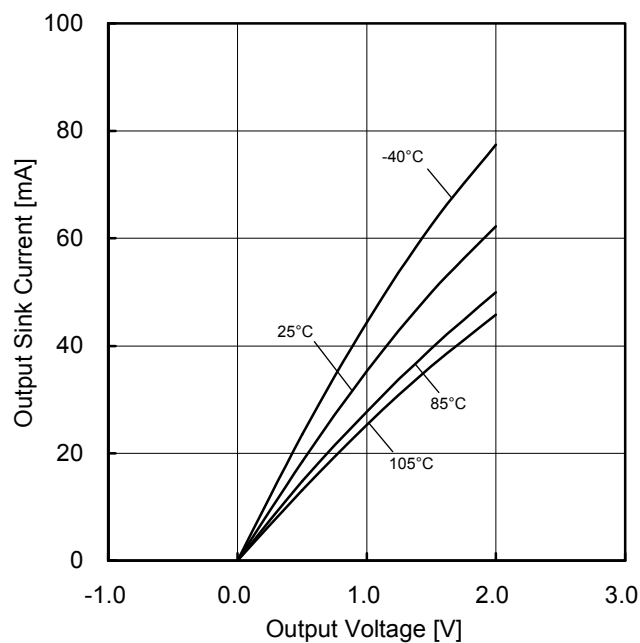


Figure 35.  
Output Sink Current vs Output Voltage  
(VDD=3V)

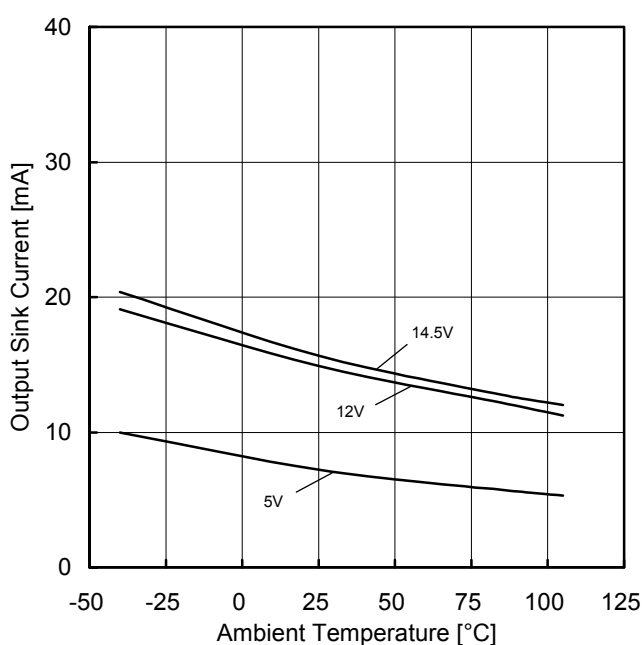


Figure 36.  
Output Sink Current vs Ambient Temperature  
(OUT=VSS+0.4V)

(\*) The above characteristics are measurements of typical sample, they are not guaranteed.  
BD7562xxx: -40°C to +85°C BD7562Sxxx: -40°C to +105°C



## Typical Performance Curves - continued

OBD7562xxx, BD7562Sxxx

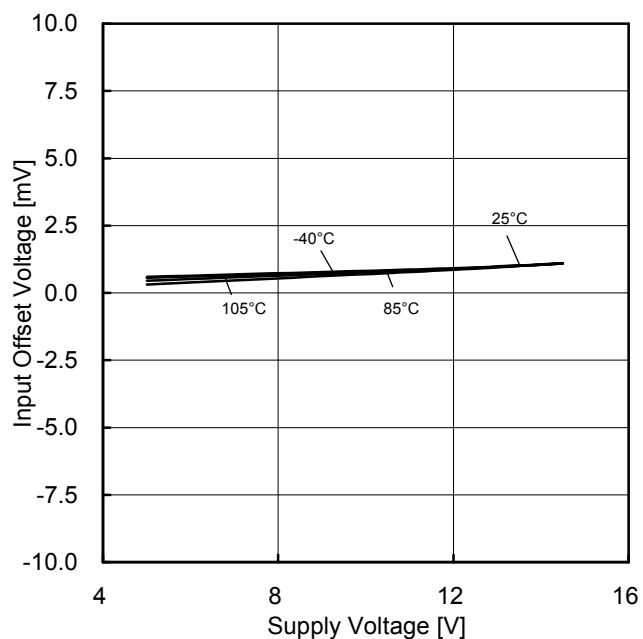


Figure 37.  
Input Offset Voltage vs Supply Voltage  
( $V_{ICM}=V_{DD}/2$ ,  $E_K=-V_{DD}/2$ )

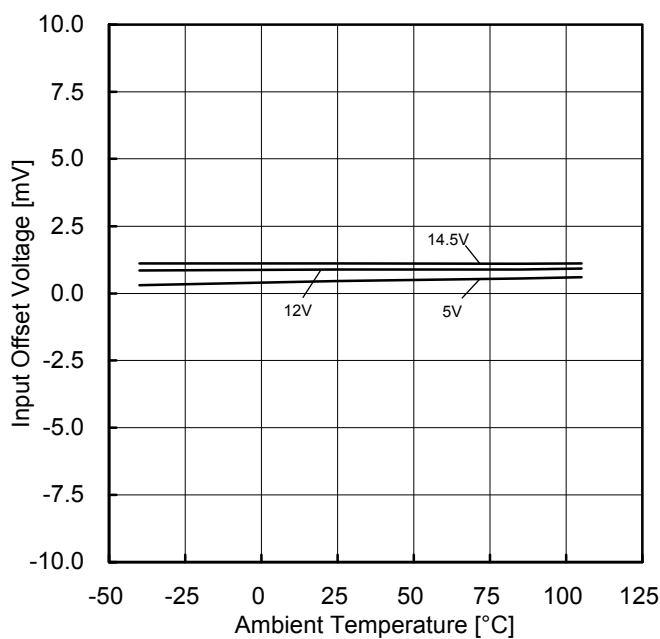


Figure 38.  
Input Offset Voltage vs Ambient Temperature  
( $V_{ICM}=V_{DD}/2$ ,  $E_K=-V_{DD}/2$ )

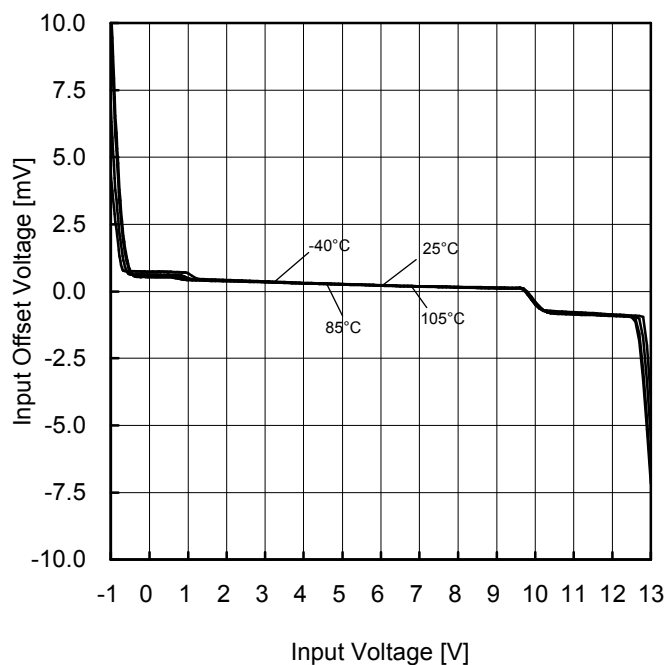


Figure 39.  
Input Offset Voltage vs Input Voltage  
( $V_{DD}=12V$ )

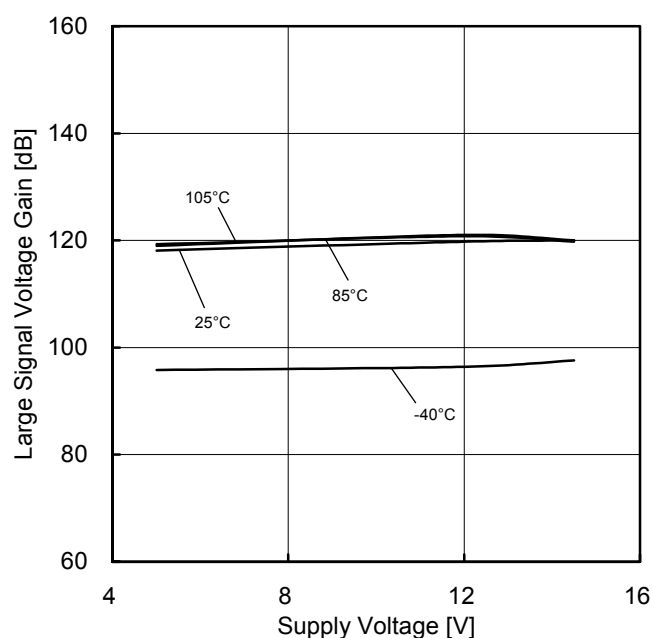


Figure 40.  
Large Signal Voltage Gain vs Supply Voltage

(\*) The above characteristics are measurements of typical sample, they are not guaranteed.  
BD7562xxx: -40°C to +85°C BD7562Sxxx: -40°C to +105°C

## Typical Performance Curves - continued

OBD7562xxx, BD7562Sxxx

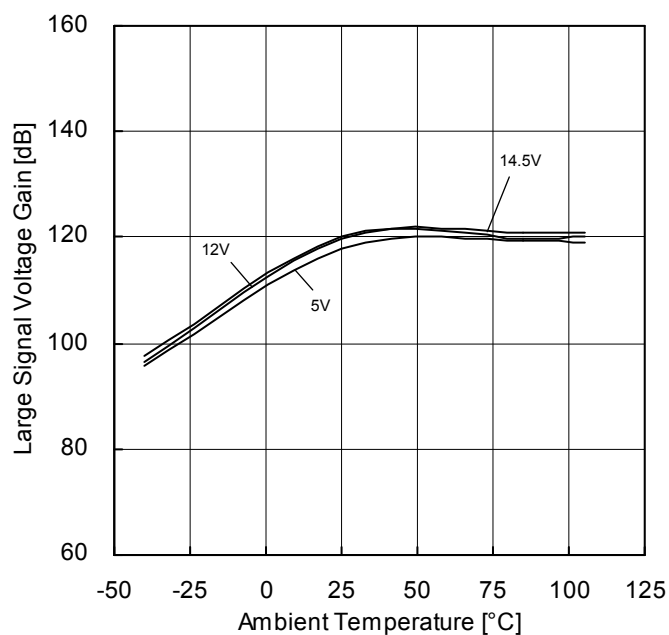


Figure 41.  
Large Signal Voltage Gain vs Ambient Temperature

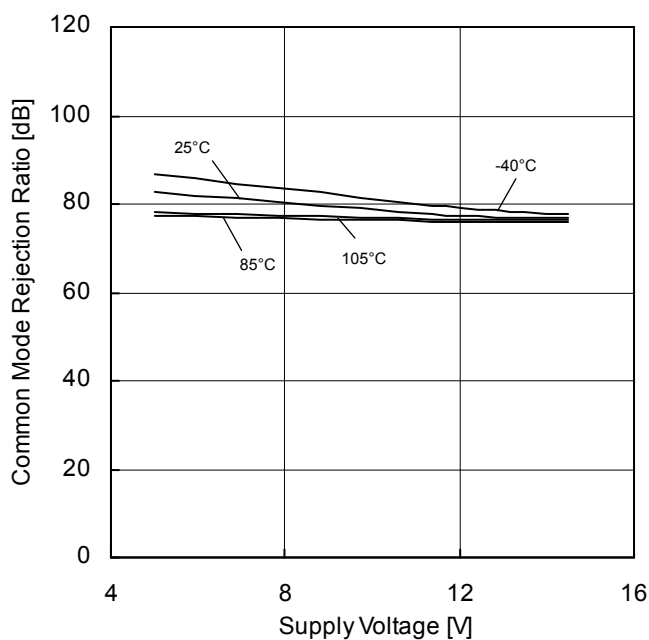


Figure 42.  
Common Mode Rejection Ratio vs Supply Voltage  
(VDD=12V)

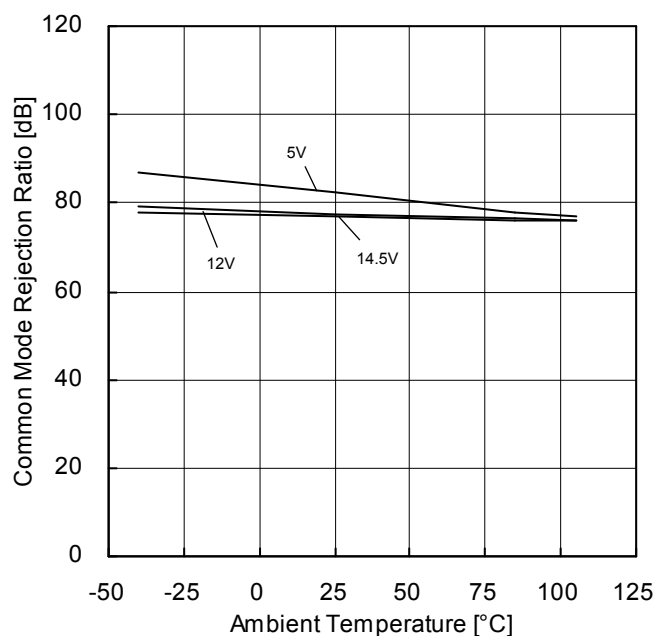


Figure 43.  
Common Mode Rejection Ratio vs Ambient Temperature  
(VDD=12V)

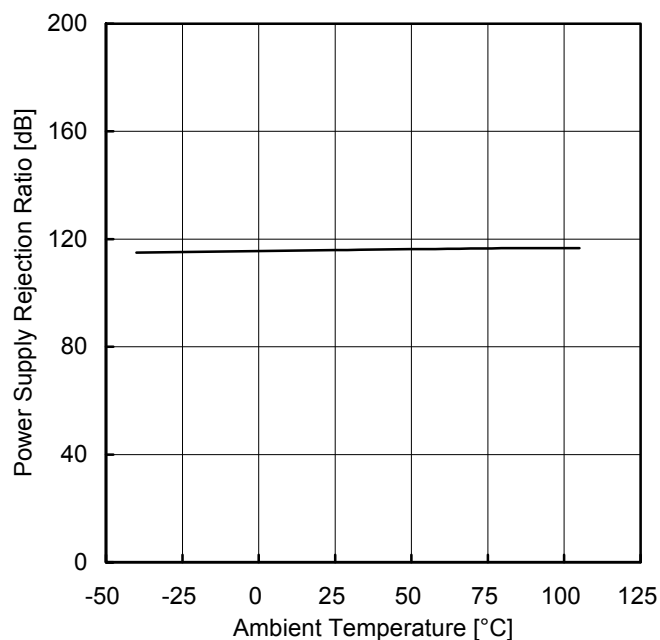


Figure 44.  
Power Supply Rejection Ratio vs Ambient Temperature

(\*) The above characteristics are measurements of typical sample, they are not guaranteed.  
BD7562xxx: -40°C to +85°C BD7562Sxxx: -40°C to +105°C

## Typical Performance Curves - continued

OBD7562xxx, BD7562Sxxx

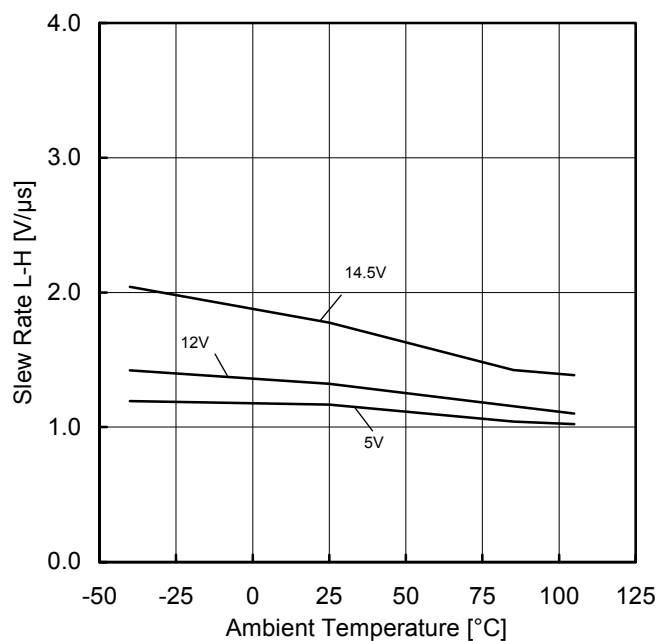


Figure 45.  
Slew Rate L-H vs Ambient Temperature

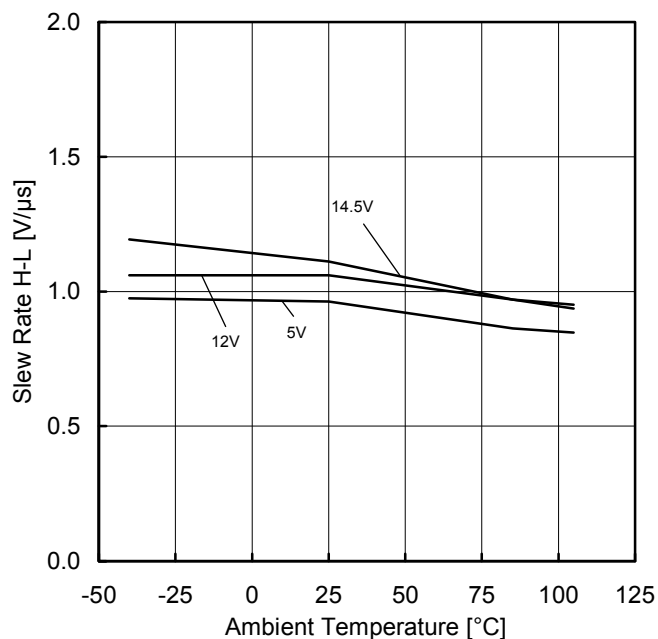


Figure 46.  
Slew Rate H-L vs Ambient Temperature

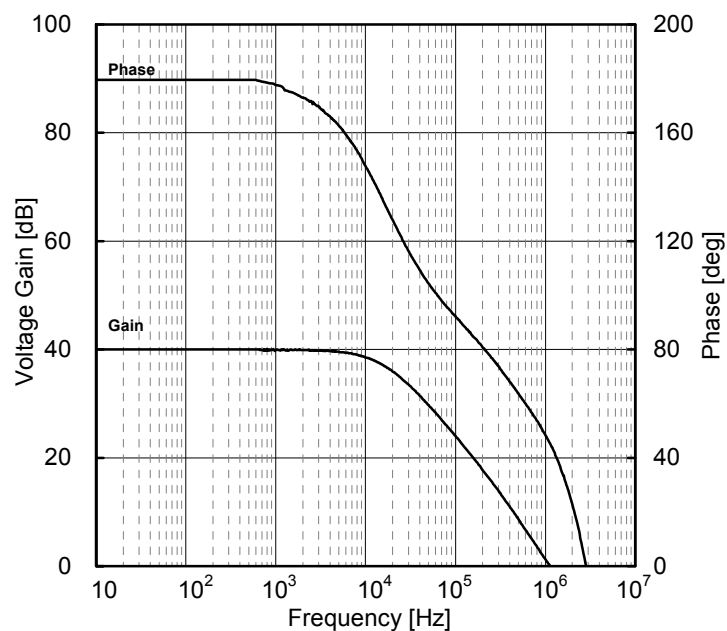


Figure 47.  
Voltage Gain • Phase vs Frequency

(\*) The above characteristics are measurements of typical sample, they are not guaranteed.  
BD7562xxx: -40°C to +85°C BD7562Sxxx: -40°C to +105°C

## Application Information

## NULL method condition for Test Circuit 1

VCC, VEE, E<sub>K</sub>, V<sub>ICM</sub> Unit: V

Parameter	V <sub>F</sub>	SW1	SW2	SW3	VDD	VSS	E <sub>K</sub>	V <sub>ICM</sub>	Calculation
Input Offset Voltage	V <sub>F1</sub>	ON	ON	OFF	12	0	-6	12	1
Large Signal Voltage Gain	V <sub>F2</sub>	ON	ON	ON	12	0	-0.5	6	2
	V <sub>F3</sub>						-11.5		
Common-Mode Rejection Ratio (Input Common-Mode Voltage Range)	V <sub>F4</sub>	ON	ON	OFF	12	0	-6	0	3
	V <sub>F5</sub>						-6	12	
Power Supply Rejection Ratio	V <sub>F6</sub>	ON	ON	OFF	5	0	-2.5	0	4
	V <sub>F7</sub>				14.5				

- Calculation -

1. Input Offset Voltage (V<sub>IO</sub>)

$$V_{IO} = \frac{|V_{F1}|}{1 + R_F/R_S} \quad [V]$$

2. Large Signal Voltage Gain (A<sub>V</sub>)

$$A_V = 20\text{Log} \frac{\Delta E_K \times (1 + R_F/R_S)}{|V_{F3} - V_{F2}|} \quad [\text{dB}]$$

3. Common-mode Rejection Ratio (CMRR)

$$\text{CMRR} = 20\text{Log} \frac{\Delta V_{ICM} \times (1 + R_F/R_S)}{|V_{F5} - V_{F4}|} \quad [\text{dB}]$$

4. Power Supply Rejection Ratio (PSRR)

$$\text{PSRR} = 20\text{Log} \frac{\Delta V_{CC} \times (1 + R_F/R_S)}{|V_{F7} - V_{F6}|} \quad [\text{dB}]$$

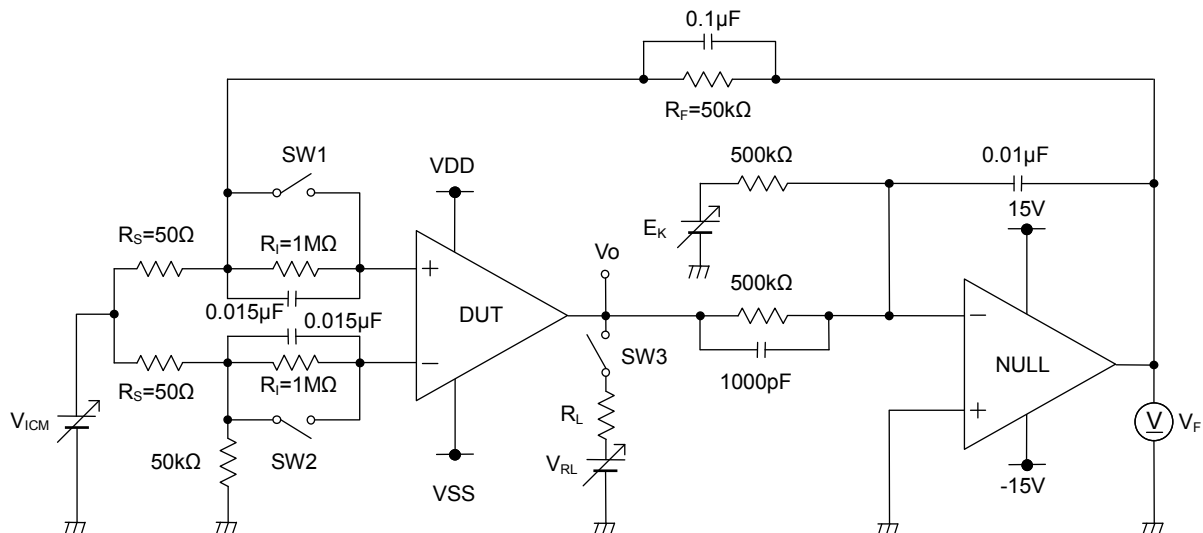


Figure 48. Test Circuit 1 (one channel only)

Switch Condition for Test Circuit 2

SW No.	SW1	SW2	SW3	SW4	SW5	SW6	SW7	SW8	SW9	SW10	SW11	SW12
Supply Current	OFF	OFF	ON	OFF	ON	OFF	OFF	OFF	OFF	OFF	OFF	OFF
Maximum Output Voltage (R <sub>L</sub> =10kΩ)	OFF	ON	OFF	OFF	ON	OFF	OFF	ON	OFF	OFF	ON	OFF
Output Current	OFF	ON	OFF	OFF	ON	OFF	OFF	OFF	OFF	ON	OFF	OFF
Slew Rate	OFF	OFF	ON	OFF	OFF	OFF	ON	OFF	ON	OFF	OFF	ON
Gain Bandwidth	ON	OFF	OFF	ON	ON	OFF	OFF	OFF	ON	OFF	OFF	ON

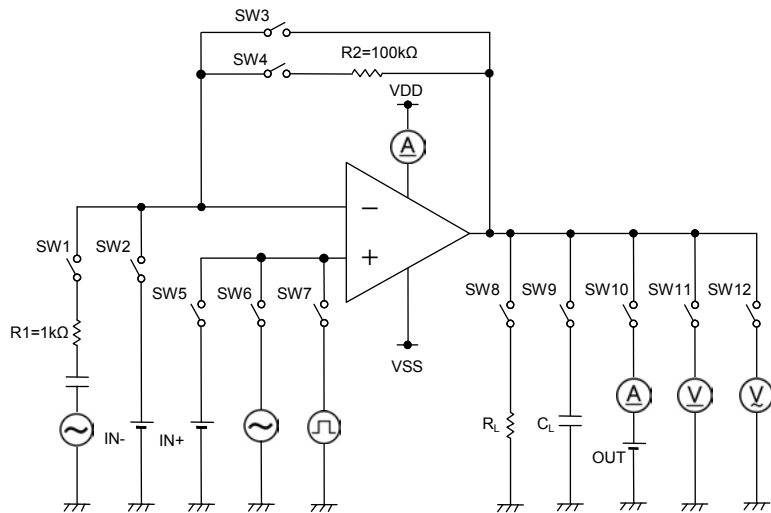


Figure 49. Test Circuit 2 (each channel)

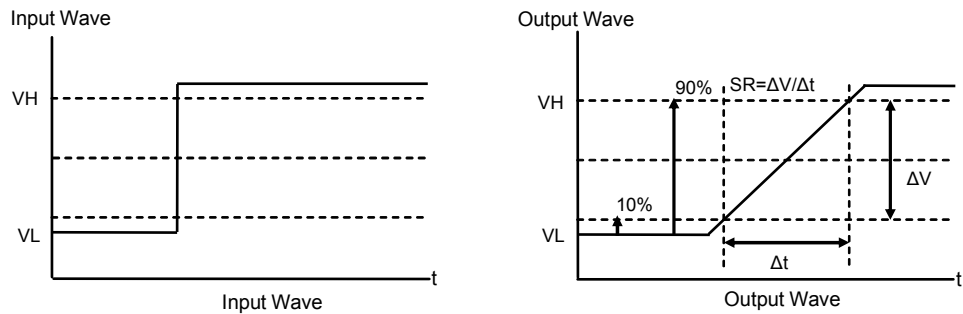


Figure 50. Slew Rate Input and Output Wave

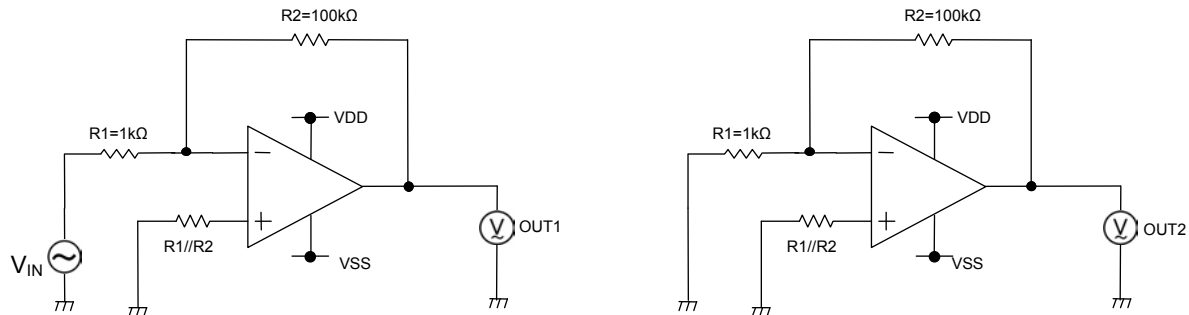


Figure 51. Test Circuit 3 (Channel Separation)

## Power Dissipation

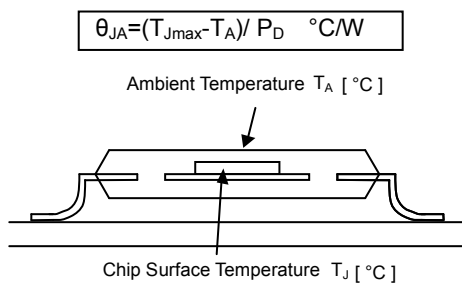
Power dissipation (total loss) indicates the power that the IC can consume at  $T_A=25^{\circ}\text{C}$  (normal temperature). As the IC consumes power, it heats up, causing its temperature to be higher than the ambient temperature. The allowable temperature that the IC can accept is limited. This depends on the circuit configuration, manufacturing process, and consumable power.

Power dissipation is determined by the allowable temperature within the IC (maximum junction temperature) and the thermal resistance of the package used (heat dissipation capability). Maximum junction temperature is typically equal to the maximum storage temperature. The heat generated through the consumption of power by the IC radiates from the mold resin or lead frame of the package. Thermal resistance, represented by the symbol  $\theta_{JA}^{\circ}\text{C/W}$ , indicates this heat dissipation capability. Similarly, the temperature of an IC inside its package can be estimated by thermal resistance.

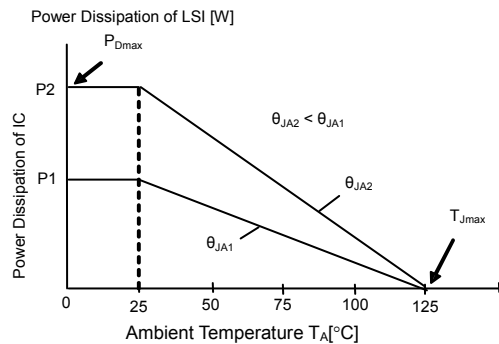
Figure 52(a) shows the model of the thermal resistance of a package. The equation below shows how to compute for the Thermal resistance ( $\theta_{JA}$ ), given the ambient temperature ( $T_A$ ), maximum junction temperature ( $T_{Jmax}$ ), and power dissipation ( $P_D$ ).

$$\theta_{JA} = (T_{Jmax} - T_A) / P_D \quad ^{\circ}\text{C/W}$$

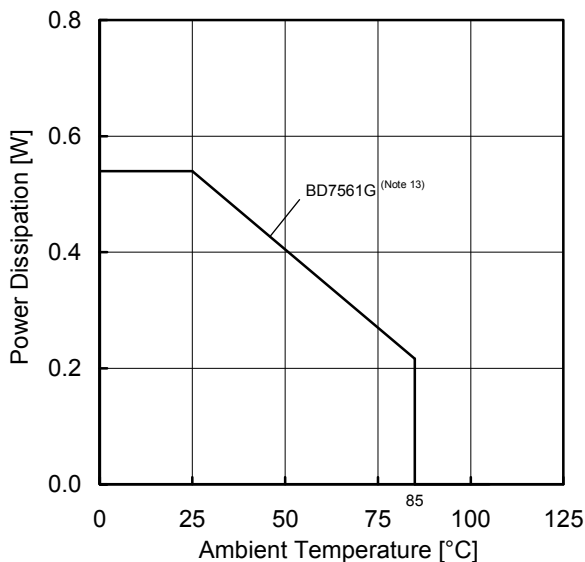
The Derating curve in Figure 52(b) indicates the power that the IC can consume with reference to ambient temperature. Power consumption of the IC begins to attenuate at certain temperatures. This gradient is determined by Thermal resistance ( $\theta_{JA}$ ), which depends on the chip size, power consumption, package, ambient temperature, package condition, wind velocity, etc. This may also vary even when the same of package is used. Thermal reduction curve indicates a reference value measured at a specified condition. Figure 52(c) to (f) shows an example of the derating curve for BD7561G, BD7561SG, BD7562xxx, and BD7562Sxxx.



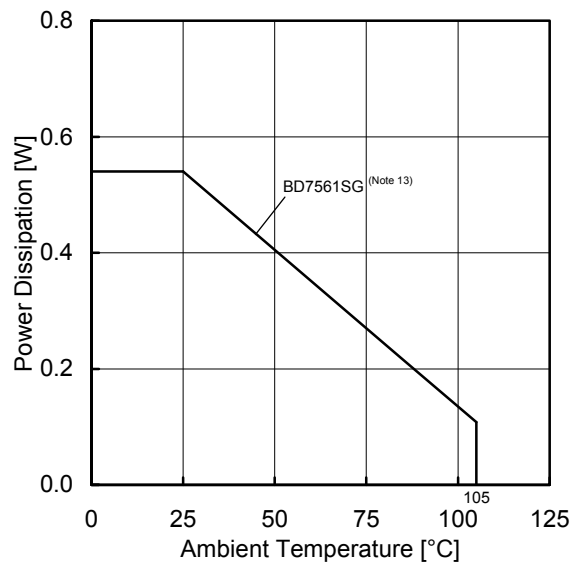
(a) Thermal Resistance



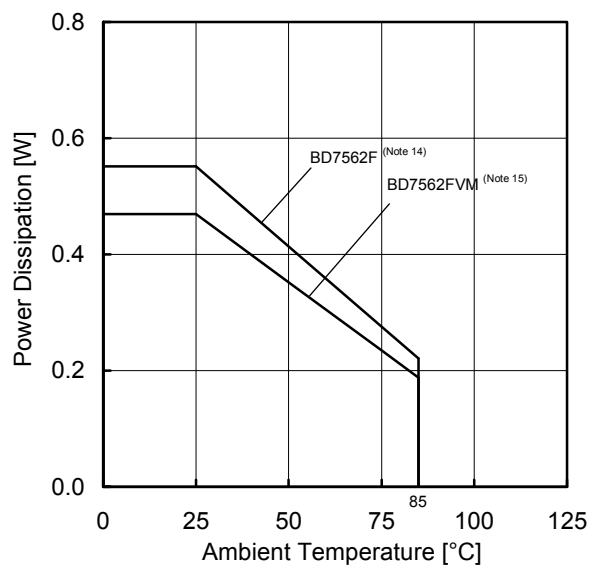
(b) Derating curve



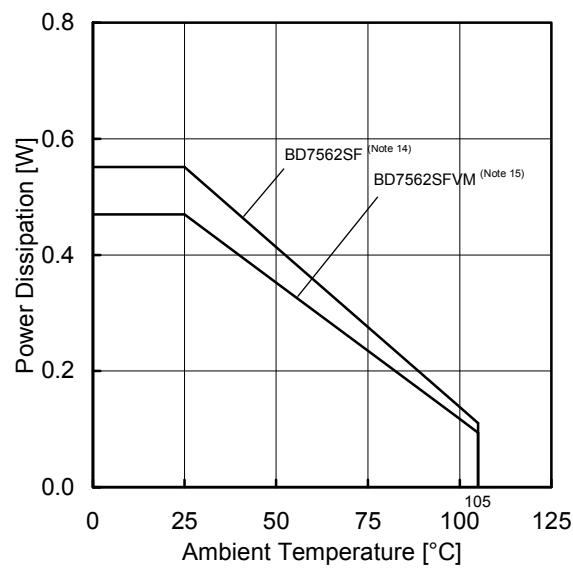
(c) BD7561G



(d) BD7561SG



(e) BD7562xxx



(f) BD7561Sxxx

Figure 52. Thermal Resistance and Derating Curve

(Note 13)	(Note 14)	(Note 15)	Unit
5.4	5.5	4.7	mW/°C

When using the unit above  $T_A=25^{\circ}\text{C}$ , subtract the value above per Celsius degree. Power dissipation is the value when FR4 glass epoxy board 70mm × 70mm × 1.6mm (copper foil area less than 3%) is mounted.

**Operational Notes****1. Reverse Connection of Power Supply**

Connecting the power supply in reverse polarity can damage the IC. Take precautions against reverse polarity when connecting the power supply, such as mounting an external diode between the power supply and the IC's power supply pins.

**2. Power Supply Lines**

Design the PCB layout pattern to provide low impedance supply lines. Separate the ground and supply lines of the digital and analog blocks to prevent noise in the ground and supply lines of the digital block from affecting the analog block. Furthermore, connect a capacitor to ground at all power supply pins. Consider the effect of temperature and aging on the capacitance value when using electrolytic capacitors.

**3. Ground Voltage**

Ensure that no pins are at a voltage below that of the ground pin at any time, even during transient condition.

**4. Ground Wiring Pattern**

When using both small-signal and large-current ground traces, the two ground traces should be routed separately but connected to a single ground at the reference point of the application board to avoid fluctuations in the small-signal ground caused by large currents. Also ensure that the ground traces of external components do not cause variations on the ground voltage. The ground lines must be as short and thick as possible to reduce line impedance.

**5. Thermal Consideration**

Should by any chance the power dissipation rating be exceeded the rise in temperature of the chip may result in deterioration of the properties of the chip. The absolute maximum rating of the  $P_D$  stated in this specification is when the IC is mounted on a 70mm x 70mm x 1.6mm glass epoxy board. In case of exceeding this absolute maximum rating, increase the board size and copper area to prevent exceeding the  $P_D$  rating.

**6. Recommended Operating Conditions**

These conditions represent a range within which the expected characteristics of the IC can be approximately obtained. The electrical characteristics are guaranteed under the conditions of each parameter.

**7. Inrush Current**

When power is first supplied to the IC, it is possible that the internal logic may be unstable and inrush current may flow instantaneously due to the internal powering sequence and delays, especially if the IC has more than one power supply. Therefore, give special consideration to power coupling capacitance, power wiring, width of ground wiring, and routing of connections.

**8. Operation Under Strong Electromagnetic Field**

Operating the IC in the presence of a strong electromagnetic field may cause the IC to malfunction.

**9. Testing on Application Boards**

When testing the IC on an application board, connecting a capacitor directly to a low-impedance output pin may subject the IC to stress. Always discharge capacitors completely after each process or step. The IC's power supply should always be turned off completely before connecting or removing it from the test setup during the inspection process. To prevent damage from static discharge, ground the IC during assembly and use similar precautions during transport and storage.

**10. Inter-pin Short and Mounting Errors**

Ensure that the direction and position are correct when mounting the IC on the PCB. Incorrect mounting may result in damaging the IC. Avoid nearby pins being shorted to each other especially to ground, power supply and output pin. Inter-pin shorts could be due to many reasons such as metal particles, water droplets (in very humid environment) and unintentional solder bridge deposited in between pins during assembly to name a few.

**11. Unused Input Pins**

Input pins of an IC are often connected to the gate of a MOS transistor. The gate has extremely high impedance and extremely low capacitance. If left unconnected, the electric field from the outside can easily charge it. The small charge acquired in this way is enough to produce a significant effect on the conduction through the transistor and cause unexpected operation of the IC. So unless otherwise specified, unused input pins should be connected to the power supply or ground line.



## Operational Notes – continued

**12. Regarding the Input Pin of the IC**

In the construction of this IC, P-N junctions are inevitably formed creating parasitic diodes or transistors. The operation of these parasitic elements can result in mutual interference among circuits, operational faults, or physical damage. Therefore, conditions which cause these parasitic elements to operate, such as applying a voltage to an input pin lower than the ground voltage should be avoided. Furthermore, do not apply a voltage to the input pins when no power supply voltage is applied to the IC. Even if the power supply voltage is applied, make sure that the input pins have voltages within the values specified in the electrical characteristics of this IC.

**13. Unused Circuits**

When there are unused op-amps, it is recommended that they are connected as in Figure 53, setting the non-inverting input terminal to a potential within the in-phase input voltage range ( $V_{ICM}$ ).

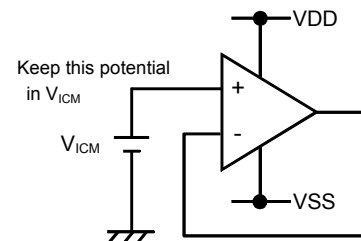


Figure 53. Example of application circuit for unused op-amp

**14. Input Voltage**

Applying VDD +0.3V to the input terminal is possible without causing deterioration of the electrical characteristics or destruction, regardless of the supply voltage. However, this does not ensure normal circuit operation. Please note that the circuit operates normally only when the input voltage is within the common mode input voltage range of the electric characteristics.

**15. Power Supply(single/dual)**

The operational amplifiers operate when the voltage supplied is between VDD and VSS. Therefore, the single supply operational amplifiers can be used as dual supply operational amplifiers as well.

**16. Output Capacitor**

If a large capacitor is connected between the output pin and VSS pin, current from the charged capacitor will flow into the output pin and may destroy the IC when the VDD pin is shorted to ground or pulled down to 0V. Use a capacitor smaller than 0.1  $\mu$ F between output pin and VSS pin.

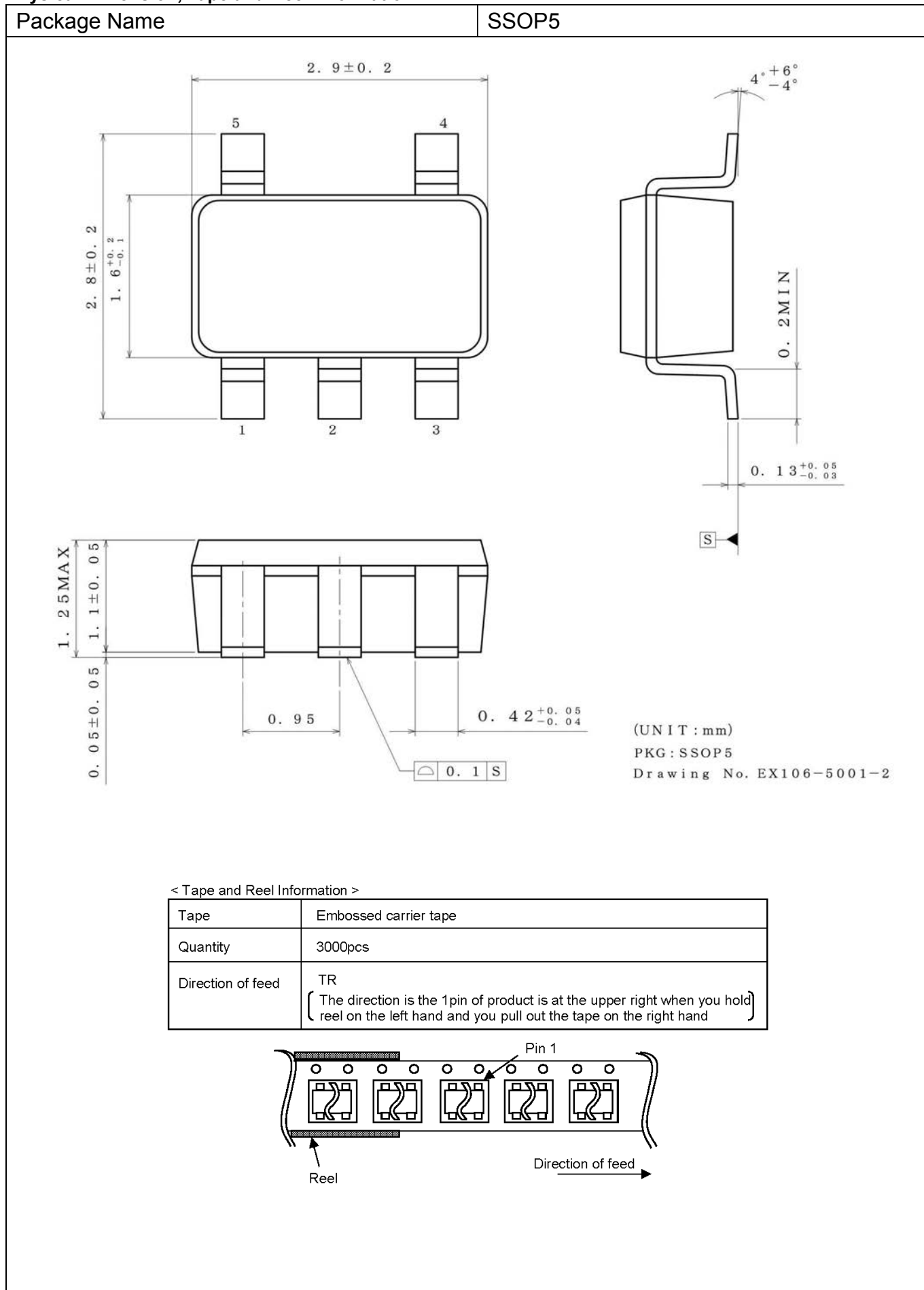
**17. Oscillation by Output Capacitor**

Please pay attention to the oscillation by output capacitor and in designing an application of negative feedback loop circuit with these ICs.

**18. Latch Up**

Be careful of input voltage that exceed the VDD and VSS. When CMOS device have sometimes occur latch up and protect the IC from abnormal noise.

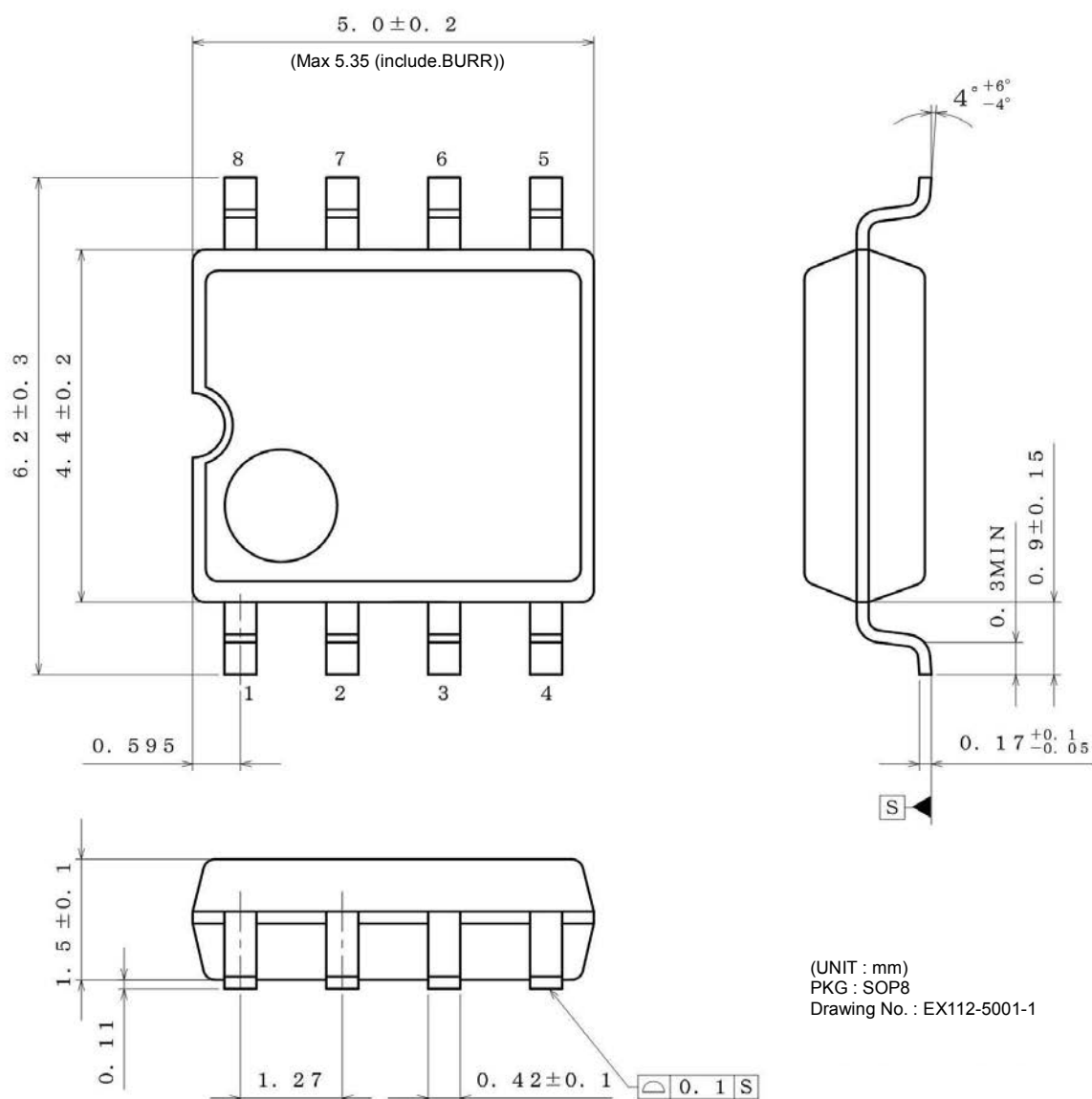
## Physical Dimension, Tape and Reel Information



## Physical Dimension Tape and Reel Information – continued

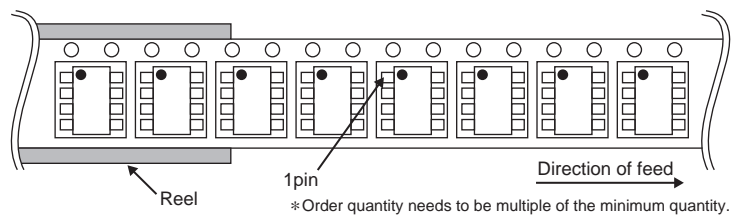
Package Name

SOP8



## &lt;Tape and Reel information&gt;

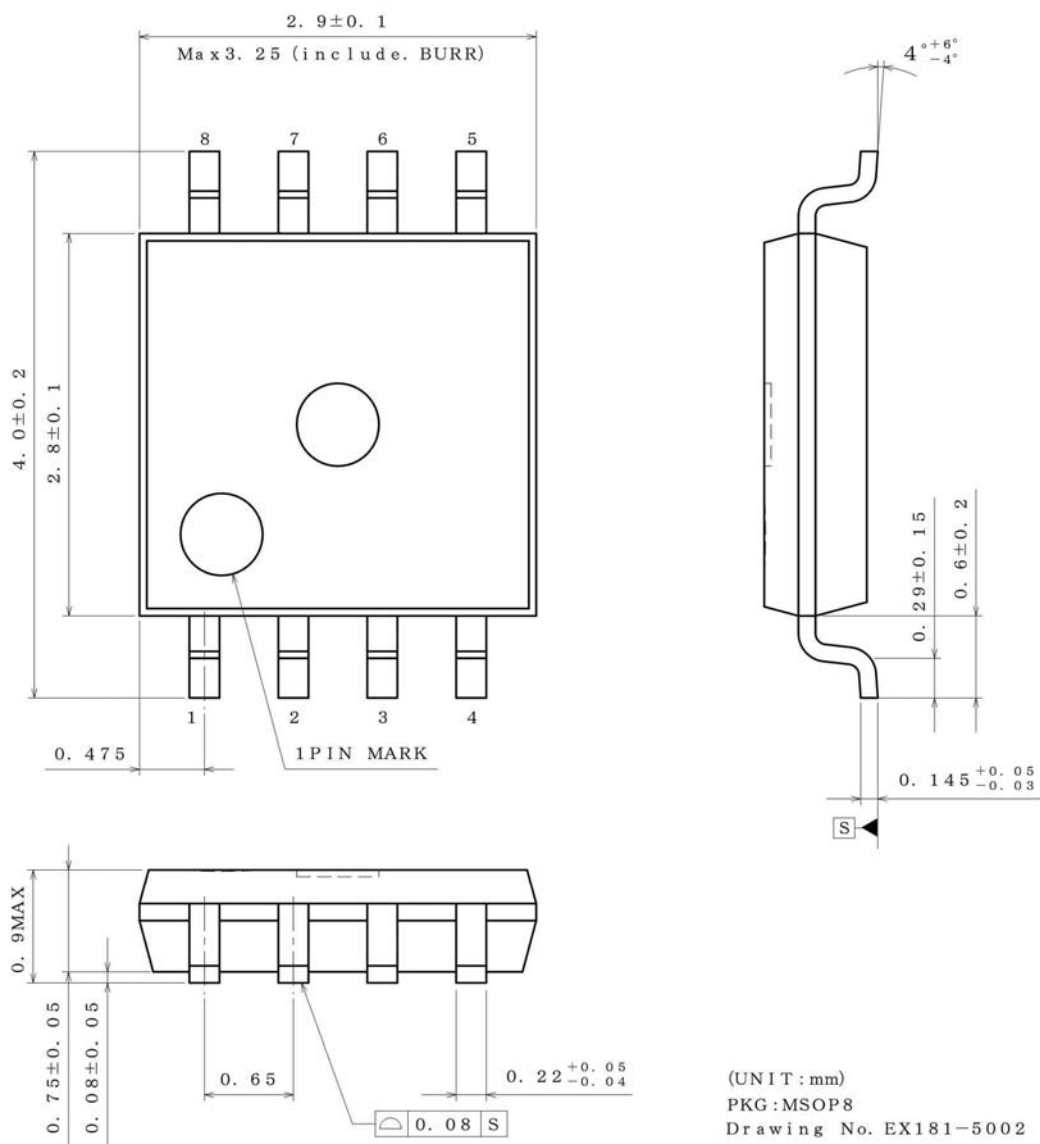
Tape	Embossed carrier tape
Quantity	2500pcs
Direction of feed	E2 (The direction is the 1pin of product is at the upper left when you hold reel on the left hand and you pull out the tape on the right hand)



## Physical Dimension Tape and Reel Information – continued

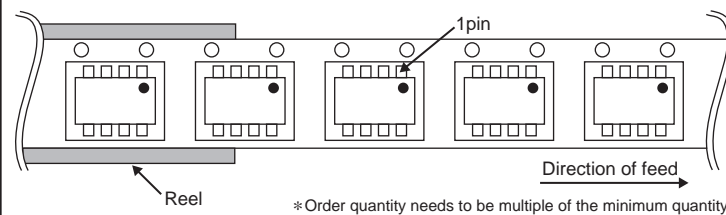
Package Name

MSOP8

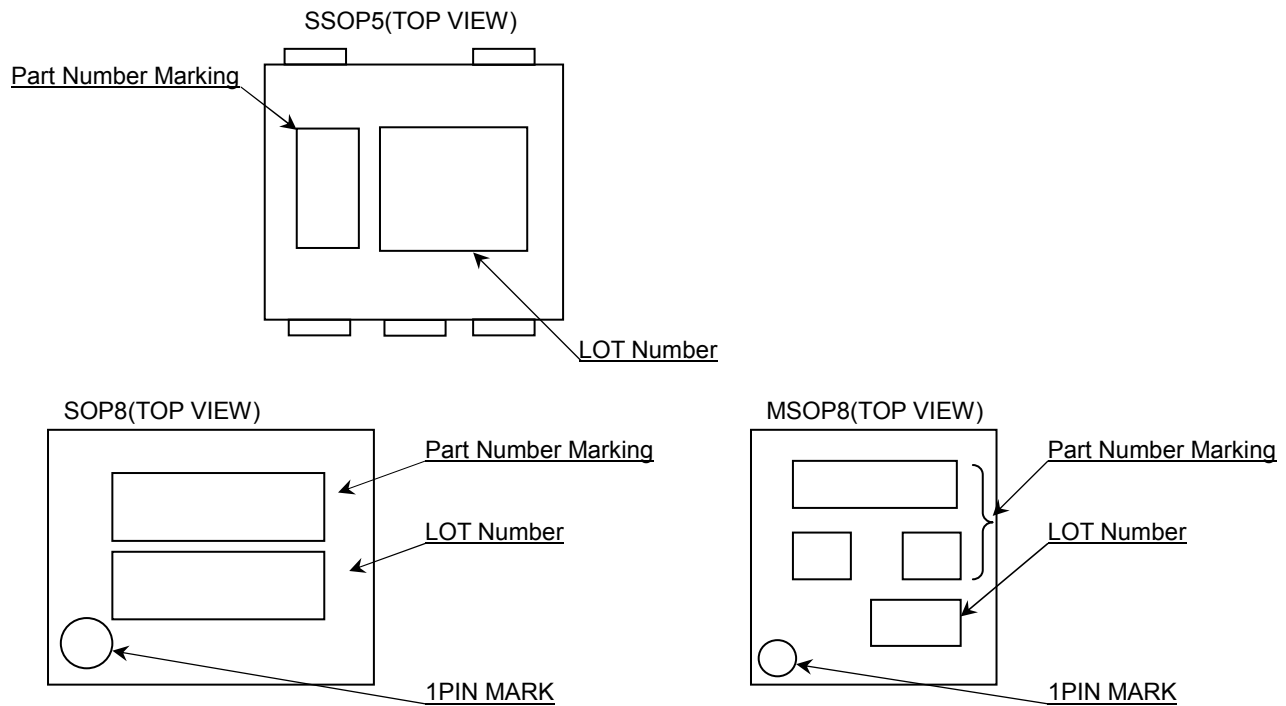


## &lt;Tape and Reel information&gt;

Tape	Embossed carrier tape
Quantity	3000pcs
Direction of feed	TR (The direction is the 1pin of product is at the upper right when you hold reel on the left hand and you pull out the tape on the right hand)



## Marking Diagram

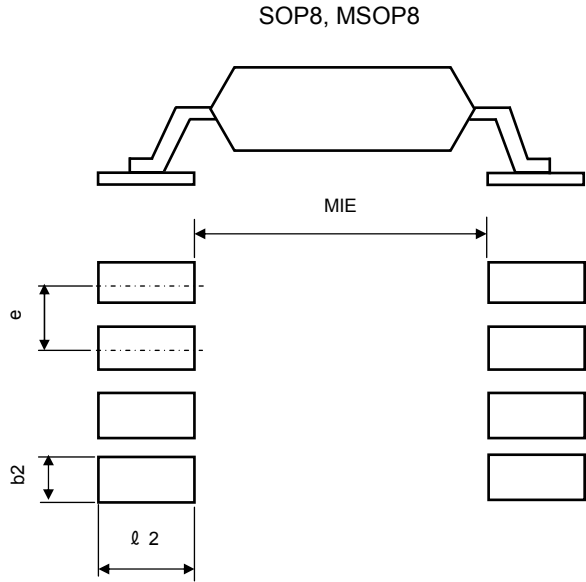
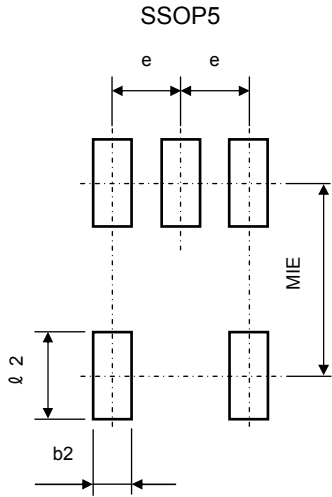


Product Name		Package Type	Marking
BD7561	G	SSOP5	AS
BD7561S			A8
BD7562	F	SOP8	7562
	FVM	MSOP8	
BD7562S	F	SOP8	7562S
	FVM	MSOP8	

Land Pattern Data

All dimensions in mm

Package	Land pitch e	Land space MIE	Land length $\geq \ell 2$	Land width b2
SSOP5	0.95	2.4	1.0	0.6
SOP8	1.27	4.60	1.10	0.76
MSOP8	0.65	2.62	0.99	0.35



Revision History

Date	Revision	Changes
20.Sep.2013	001	New Release

# Notice

## Precaution on using ROHM Products

- Our Products are designed and manufactured for application in ordinary electronic equipments (such as AV equipment, OA equipment, telecommunication equipment, home electronic appliances, amusement equipment, etc.). If you intend to use our Products in devices requiring extremely high reliability (such as medical equipment <sup>(Note 1)</sup>, transport equipment, traffic equipment, aircraft/spacecraft, nuclear power controllers, fuel controllers, car equipment including car accessories, safety devices, etc.) and whose malfunction or failure may cause loss of human life, bodily injury or serious damage to property ("Specific Applications"), please consult with the ROHM sales representative in advance. Unless otherwise agreed in writing by ROHM in advance, ROHM shall not be in any way responsible or liable for any damages, expenses or losses incurred by you or third parties arising from the use of any ROHM's Products for Specific Applications.

(Note1) Medical Equipment Classification of the Specific Applications

JAPAN	USA	EU	CHINA
CLASS III	CLASS III	CLASS II b	CLASS III
CLASS IV		CLASS III	

- ROHM designs and manufactures its Products subject to strict quality control system. However, semiconductor products can fail or malfunction at a certain rate. Please be sure to implement, at your own responsibilities, adequate safety measures including but not limited to fail-safe design against the physical injury, damage to any property, which a failure or malfunction of our Products may cause. The following are examples of safety measures:
  - Installation of protection circuits or other protective devices to improve system safety
  - Installation of redundant circuits to reduce the impact of single or multiple circuit failure
- Our Products are designed and manufactured for use under standard conditions and not under any special or extraordinary environments or conditions, as exemplified below. Accordingly, ROHM shall not be in any way responsible or liable for any damages, expenses or losses arising from the use of any ROHM's Products under any special or extraordinary environments or conditions. If you intend to use our Products under any special or extraordinary environments or conditions (as exemplified below), your independent verification and confirmation of product performance, reliability, etc. prior to use, must be necessary:
  - Use of our Products in any types of liquid, including water, oils, chemicals, and organic solvents
  - Use of our Products outdoors or in places where the Products are exposed to direct sunlight or dust
  - Use of our Products in places where the Products are exposed to sea wind or corrosive gases, including Cl<sub>2</sub>, H<sub>2</sub>S, NH<sub>3</sub>, SO<sub>2</sub>, and NO<sub>2</sub>
  - Use of our Products in places where the Products are exposed to static electricity or electromagnetic waves
  - Use of our Products in proximity to heat-producing components, plastic cords, or other flammable items
  - Sealing or coating our Products with resin or other coating materials
  - Use of our Products without cleaning residue of flux (even if you use no-clean type fluxes, cleaning residue of flux is recommended); or Washing our Products by using water or water-soluble cleaning agents for cleaning residue after soldering
  - Use of the Products in places subject to dew condensation
- The Products are not subject to radiation-proof design.
- Please verify and confirm characteristics of the final or mounted products in using the Products.
- In particular, if a transient load (a large amount of load applied in a short period of time, such as pulse. is applied, confirmation of performance characteristics after on-board mounting is strongly recommended. Avoid applying power exceeding normal rated power; exceeding the power rating under steady-state loading condition may negatively affect product performance and reliability.
- De-rate Power Dissipation (Pd) depending on Ambient temperature (Ta). When used in sealed area, confirm the actual ambient temperature.
- Confirm that operation temperature is within the specified range described in the product specification.
- ROHM shall not be in any way responsible or liable for failure induced under deviant condition from what is defined in this document.

## Precaution for Mounting / Circuit board design

- When a highly active halogenous (chlorine, bromine, etc.) flux is used, the residue of flux may negatively affect product performance and reliability.
- In principle, the reflow soldering method must be used; if flow soldering method is preferred, please consult with the ROHM representative in advance.

For details, please refer to ROHM Mounting specification

## Precautions Regarding Application Examples and External Circuits

1. If change is made to the constant of an external circuit, please allow a sufficient margin considering variations of the characteristics of the Products and external components, including transient characteristics, as well as static characteristics.
2. You agree that application notes, reference designs, and associated data and information contained in this document are presented only as guidance for Products use. Therefore, in case you use such information, you are solely responsible for it and you must exercise your own independent verification and judgment in the use of such information contained in this document. ROHM shall not be in any way responsible or liable for any damages, expenses or losses incurred by you or third parties arising from the use of such information.

## Precaution for Electrostatic

This Product is electrostatic sensitive product, which may be damaged due to electrostatic discharge. Please take proper caution in your manufacturing process and storage so that voltage exceeding the Products maximum rating will not be applied to Products. Please take special care under dry condition (e.g. Grounding of human body / equipment / solder iron, isolation from charged objects, setting of ionizer, friction prevention and temperature / humidity control).

## Precaution for Storage / Transportation

1. Product performance and soldered connections may deteriorate if the Products are stored in the places where:
  - [a] the Products are exposed to sea winds or corrosive gases, including Cl<sub>2</sub>, H<sub>2</sub>S, NH<sub>3</sub>, SO<sub>2</sub>, and NO<sub>2</sub>
  - [b] the temperature or humidity exceeds those recommended by ROHM
  - [c] the Products are exposed to direct sunshine or condensation
  - [d] the Products are exposed to high Electrostatic
2. Even under ROHM recommended storage condition, solderability of products out of recommended storage time period may be degraded. It is strongly recommended to confirm solderability before using Products of which storage time is exceeding the recommended storage time period.
3. Store / transport cartons in the correct direction, which is indicated on a carton with a symbol. Otherwise bent leads may occur due to excessive stress applied when dropping of a carton.
4. Use Products within the specified time after opening a humidity barrier bag. Baking is required before using Products of which storage time is exceeding the recommended storage time period.

## Precaution for Product Label

QR code printed on ROHM Products label is for ROHM's internal use only.

## Precaution for Disposition

When disposing Products please dispose them properly using an authorized industry waste company.

## Precaution for Foreign Exchange and Foreign Trade act

Since our Products might fall under controlled goods prescribed by the applicable foreign exchange and foreign trade act, please consult with ROHM representative in case of export.

## Precaution Regarding Intellectual Property Rights

1. All information and data including but not limited to application example contained in this document is for reference only. ROHM does not warrant that foregoing information or data will not infringe any intellectual property rights or any other rights of any third party regarding such information or data. ROHM shall not be in any way responsible or liable for infringement of any intellectual property rights or other damages arising from use of such information or data.:
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## Other Precaution

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**General Precaution**

1. Before you use our Products, you are requested to carefully read this document and fully understand its contents. ROHM shall not be in any way responsible or liable for failure, malfunction or accident arising from the use of any ROHM's Products against warning, caution or note contained in this document.
2. All information contained in this document is current as of the issuing date and subject to change without any prior notice. Before purchasing or using ROHM's Products, please confirm the latest information with a ROHM sales representative.
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